

A 180 GHZ ACCELERATOR MADE FROM ELECTROFORMED COPPER

Presenter: B. Popovic, **APS/ANL**

On Behalf of:

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S. Doran (**HEP/ANL**)

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A. Siy³, N. Behdad, J. Booske (**University of Wisconsin**)

1) now at LANL 2) at Quaise Energy

A. Zholents, S. Baturin, S. Doran, W. Jansma, et al., 18 coauthors, “A *high repetition rate millimeter wavelength accelerator for an X-ray free-electron laser*”, Journal of Instrumentation, JINST 20 P01023 (2025), <https://doi.org/10.1088/1748-0221/20/01/P01023>

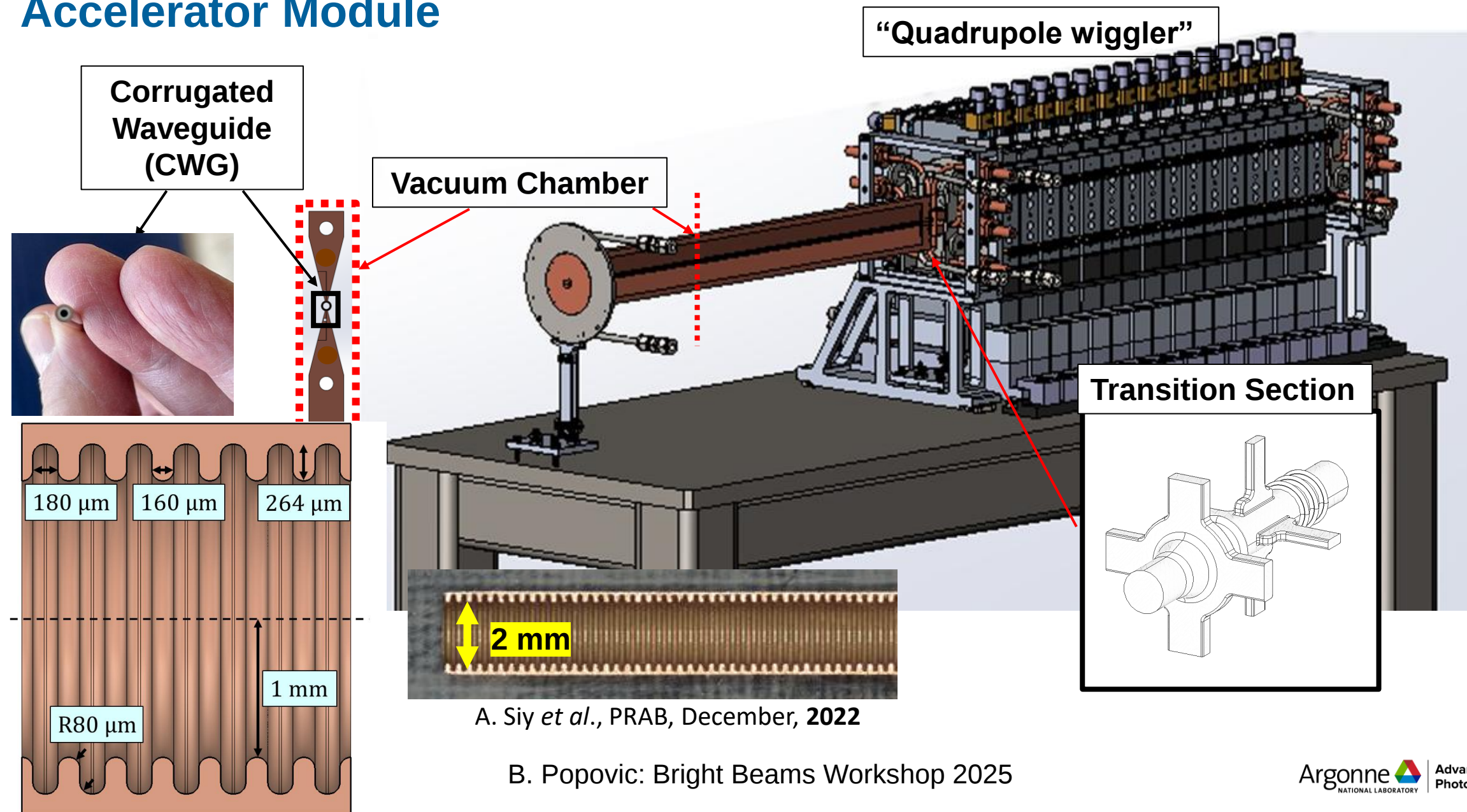
OVERVIEW

- Motivation
 - Components Beam Tested
- Corrugated Waveguide Interaction Structure
 - Fabrication Techniques Explored
 - Electroforming
- Transition Section Fabrication
 - Brazing Issues
- Future Work

ARGONNE SUB-TERAHERTZ ACCELERATOR: ASTAR

Accelerator Module

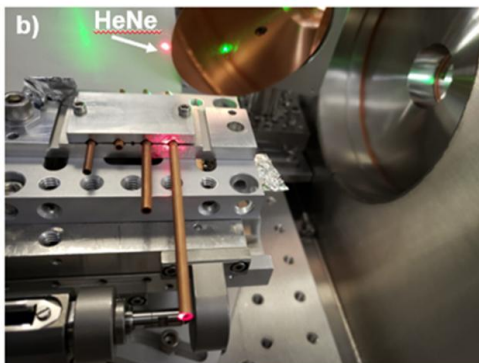
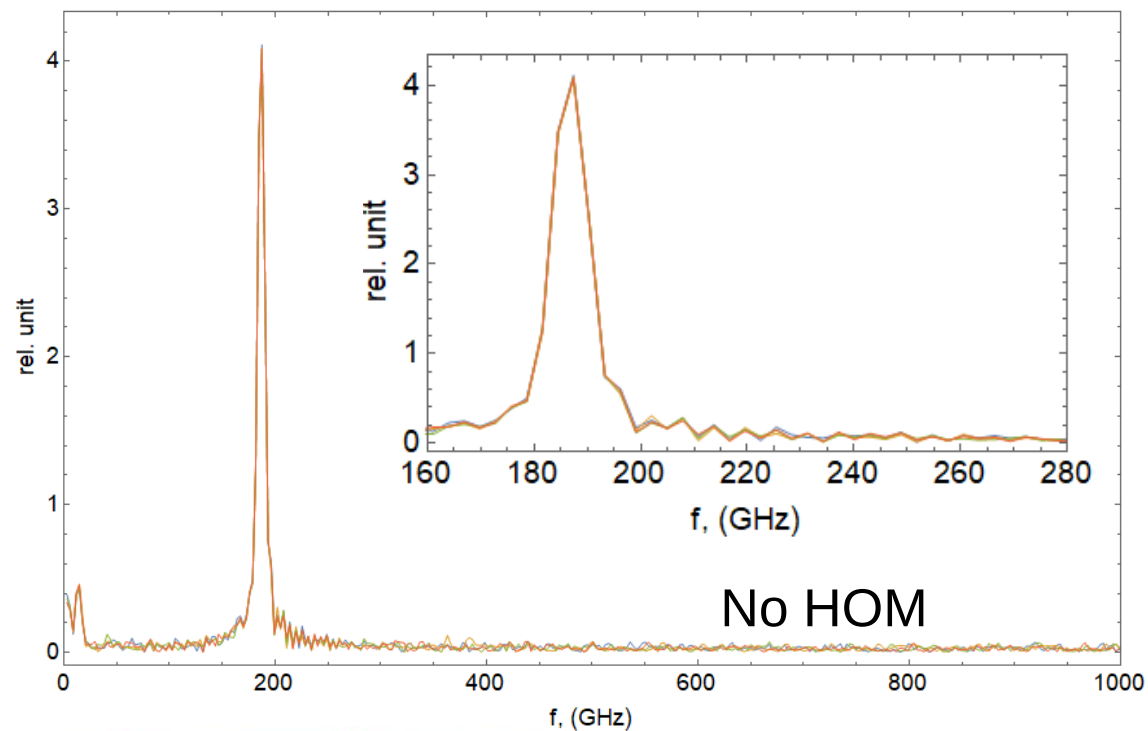
3



COMPONENTS TESTED AT BNL ATF

4

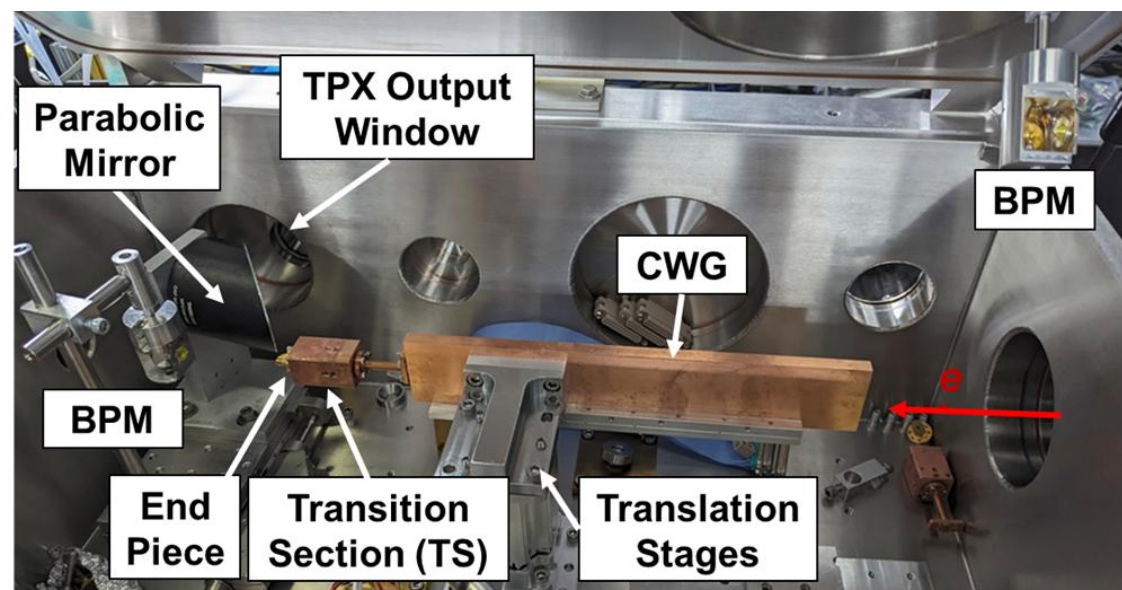
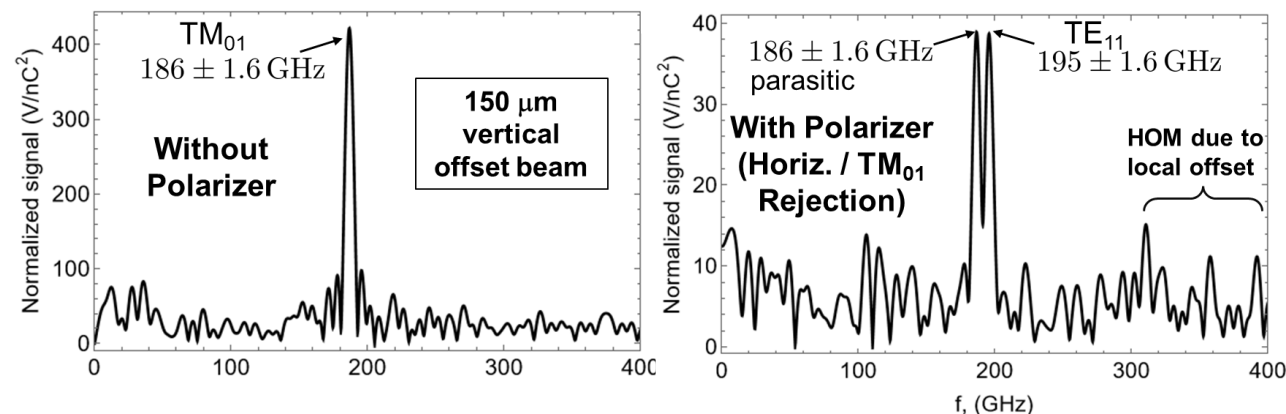
Corrugated Waveguide



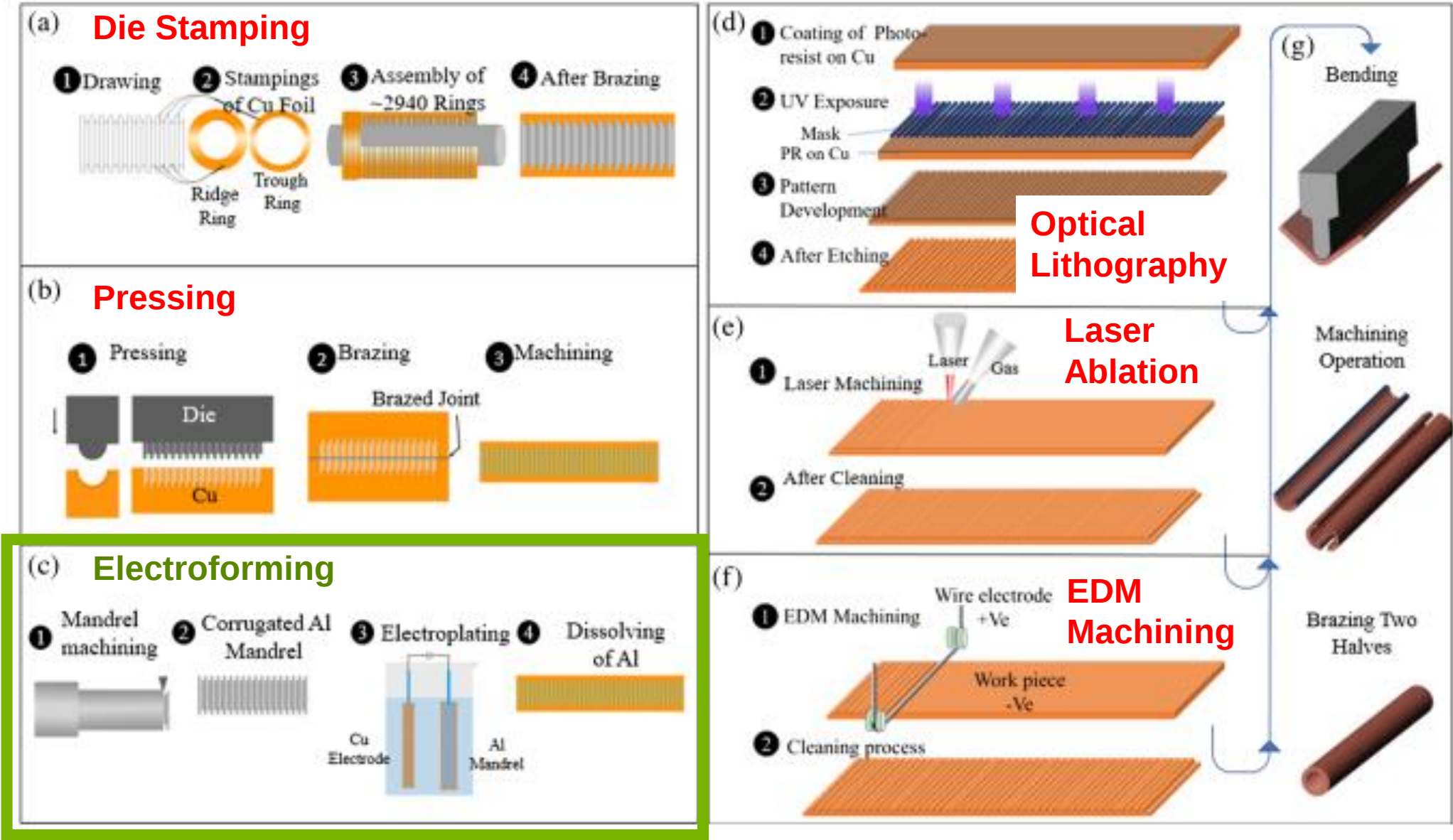
Tube with a smooth wall



Transition Section



FABRICATION TECHNIQUES EXPLORED



TECHNIQUES EXPLORED

(a) Die Stamping

1 Drawing

- Virtual leaks
- Vacuum level
- Too many joints
- Brazing is difficult

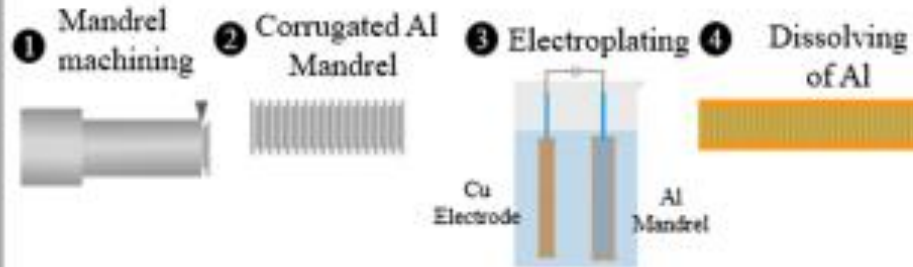
Brazing

(b) Pressing

1 Pressing

- Brazing related issues,
- Joint matching and flow of melted metal in the structure

(c) Electroforming



(d) Optical Lithography

- Modulation in patterns leads to RF issues

1 Coating of Photoresist on Cu

Development

4 After Etching

Optical Lithography

(e) Laser Ablation

- Surface finish
- RF related issues due to surface finish

Laser Gas

Laser Ablation

(f) EDM

- Brazing related issues,
- Joint matching and flow of melted metal in the structure

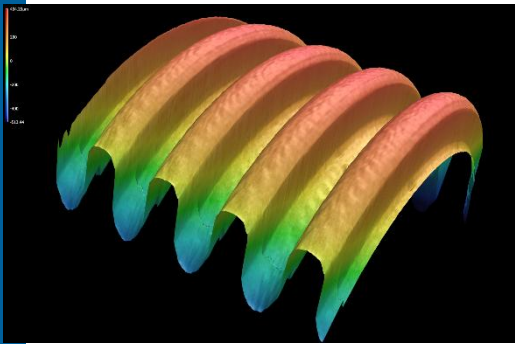
(g) Bending

Bending

- Issues joining two halves
- Labor intensive e-beam welding
- Heating and expansion of thin walls of tube
- Penetration of inside tube

Electroforming circular corrugated waveguide

Aluminum mandrel production



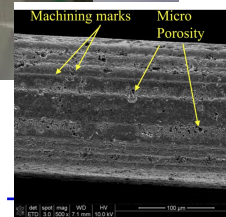
High-Quality
Surface
Finish

Proprietary micro-machining process
Tooth Height $252.7\text{ }\mu\text{m}$; error $1.5\text{ }\mu\text{m RMS}$
Tooth Width $175.9\text{ }\mu\text{m}$; error $2.0\text{ }\mu\text{m RMS}$

Mandrel inspection and straightening



using optical comparator



Electroforming



reference
groove

EDM of outside diameter OD

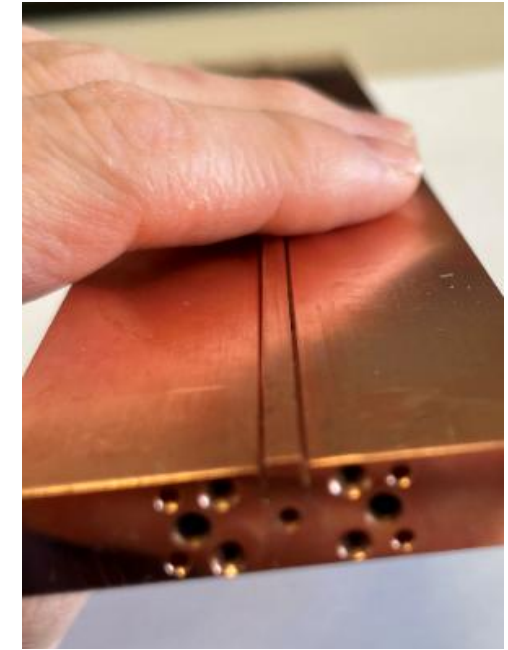


followed by second straightening

Precision cut of edges



followed by aluminum etching



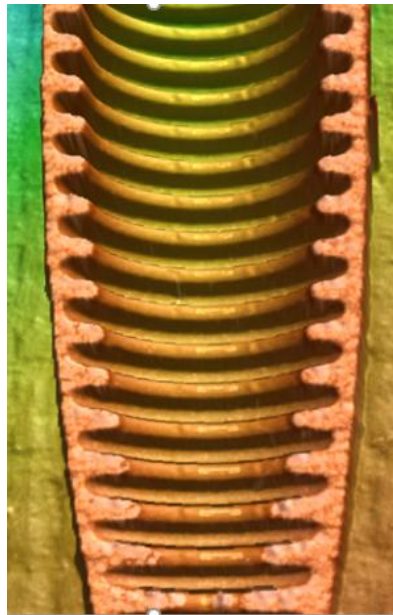
low temperature brazing at $365\text{ }^{\circ}\text{C}$
Brazing alloy: 88% Au and 12% Ge

Measurements indicate excellent CWG fabrication quality

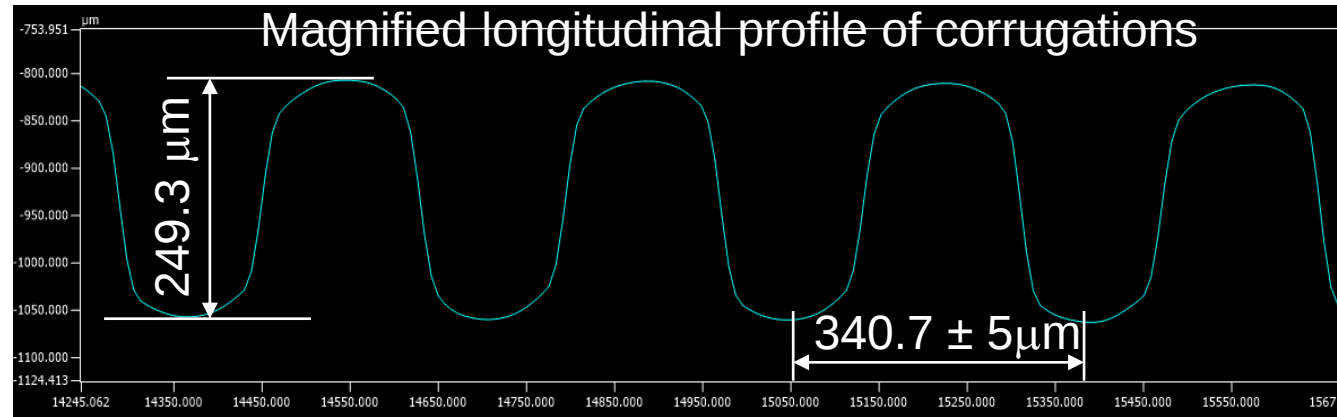
straight cut



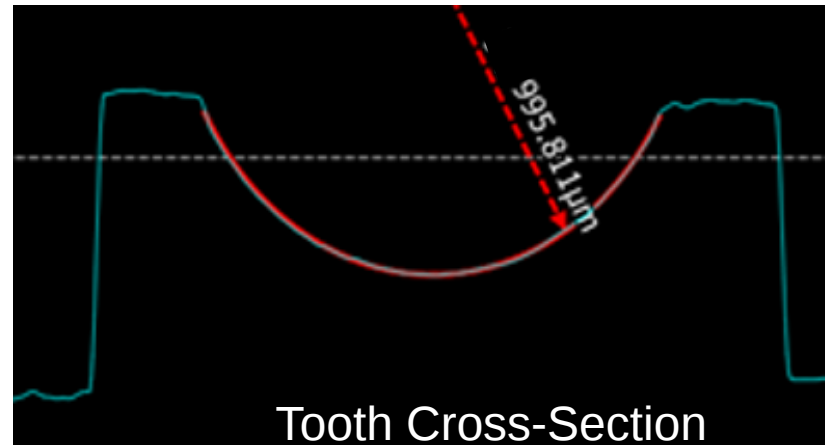
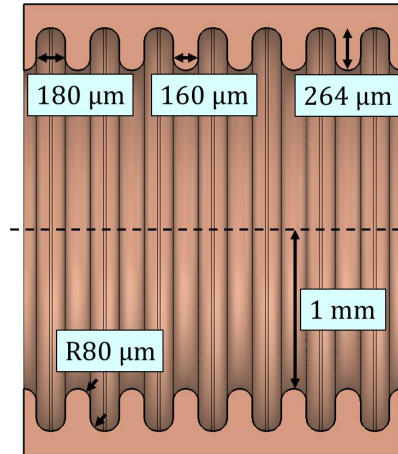
Test samples are wire EDM cut to expose the internal corrugations for dimensional analysis



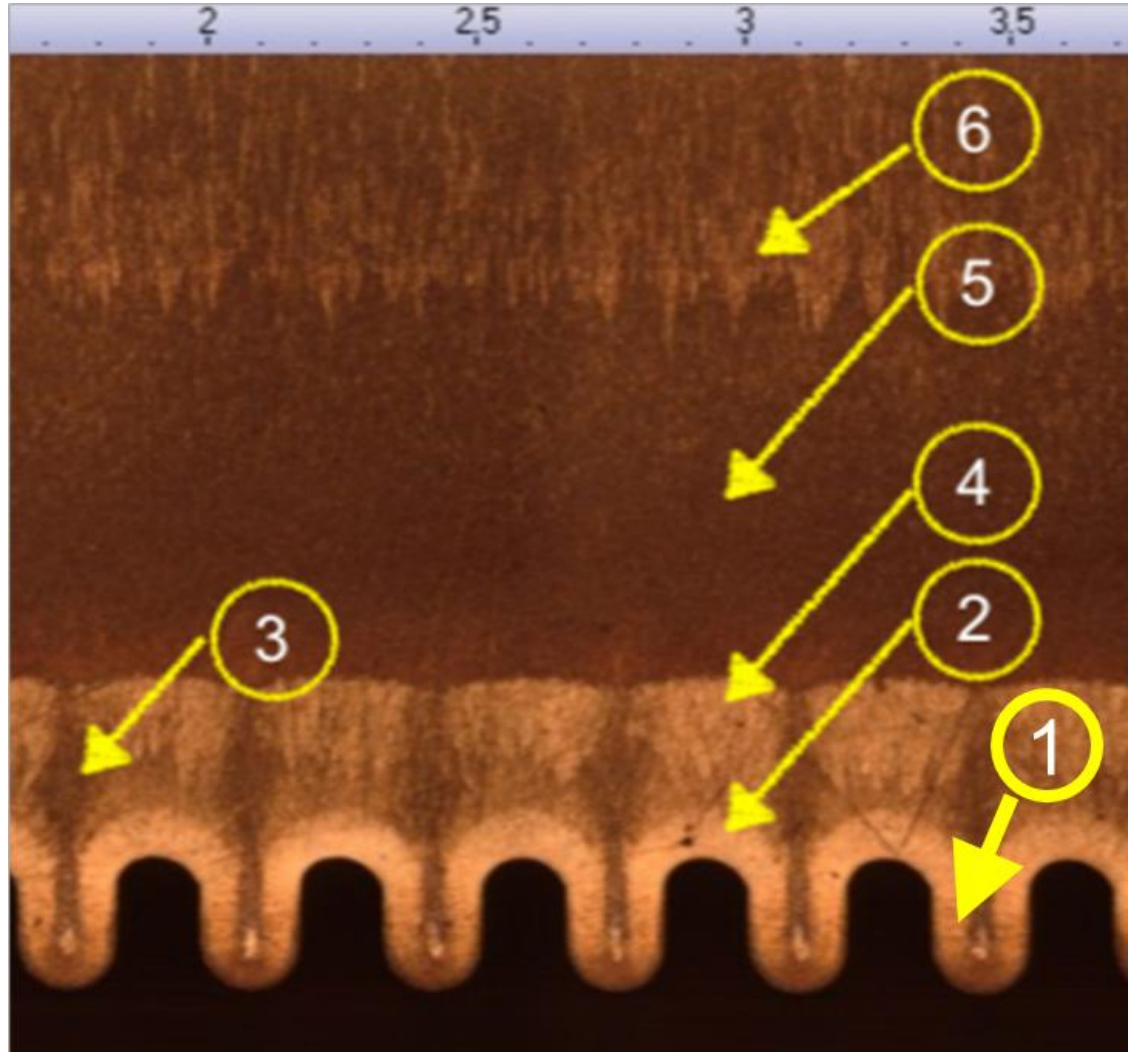
angular cut



Average height of the corrugations of 249.7 μm was determined.

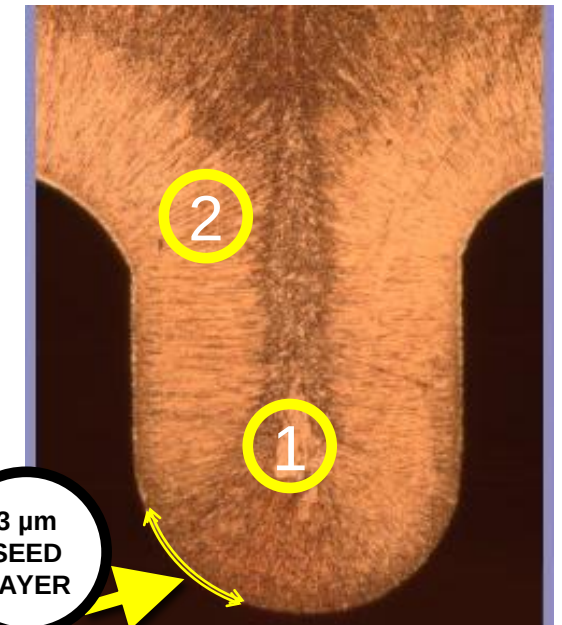
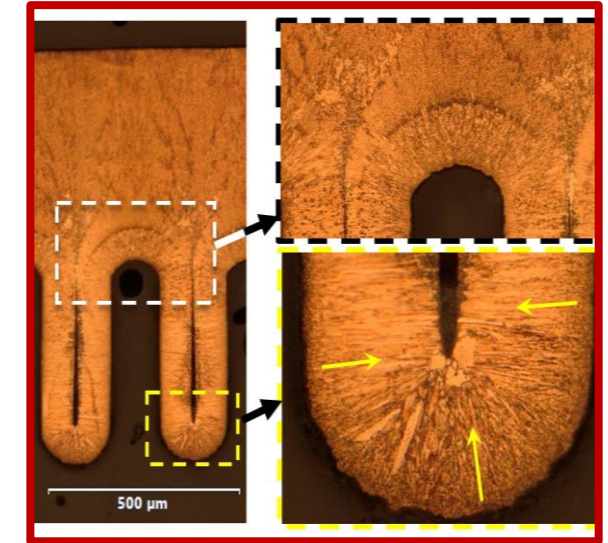


MICROSTRUCTURE OF CORRUGATIONS

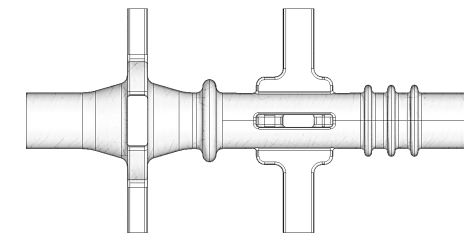


Sample from
Servometer Drove
Design Constraints

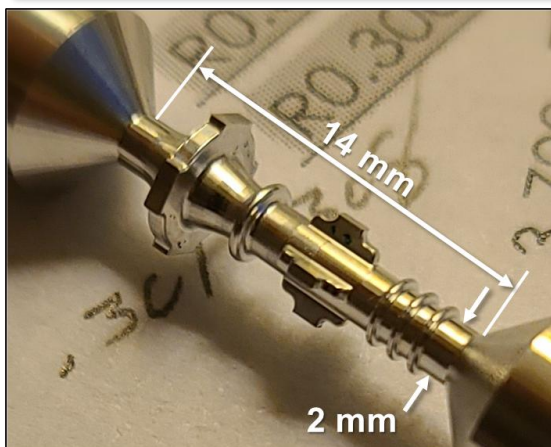
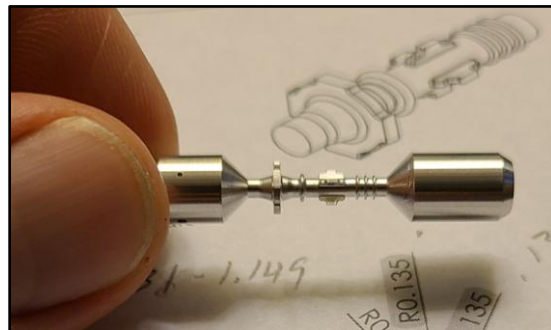
K. Suthar, G. Navrotski,
P. Carriere, and A.
Zholents, “Study of
copper microstructure
produced by
electroforming for the
180-GHz frequency
corrugated waveguide”,
Mech. Eng. Design of
Synchrotron Radiat.
Equip. and Instrum.,
MEDSI2020, Chicago,



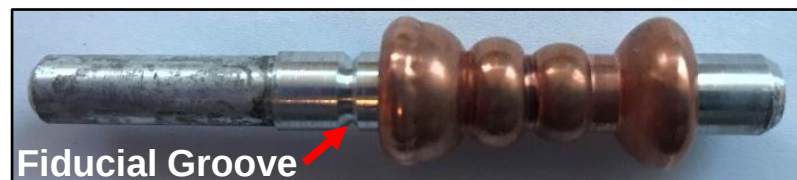
FABRICATION PROCESS: ALUMINUM MANDREL TO TS CORE



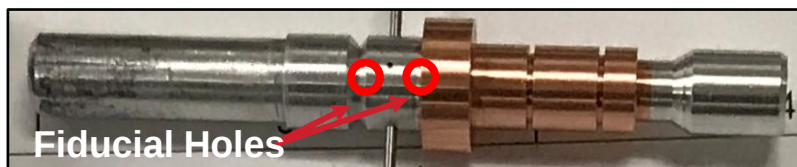
Aluminum Mandrel



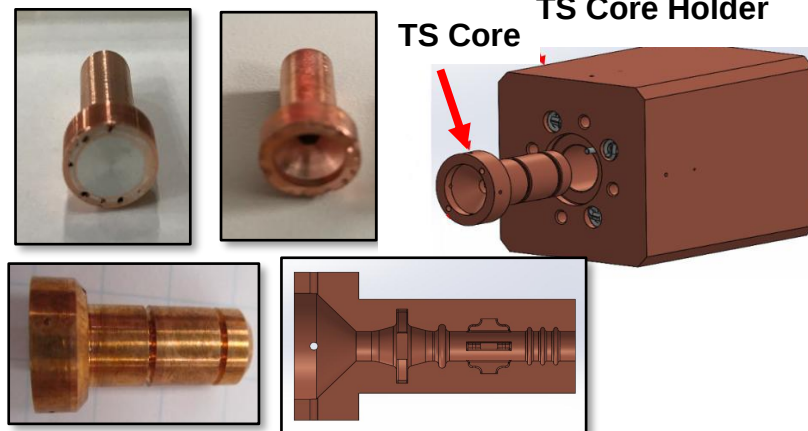
Electroformed Mandrel



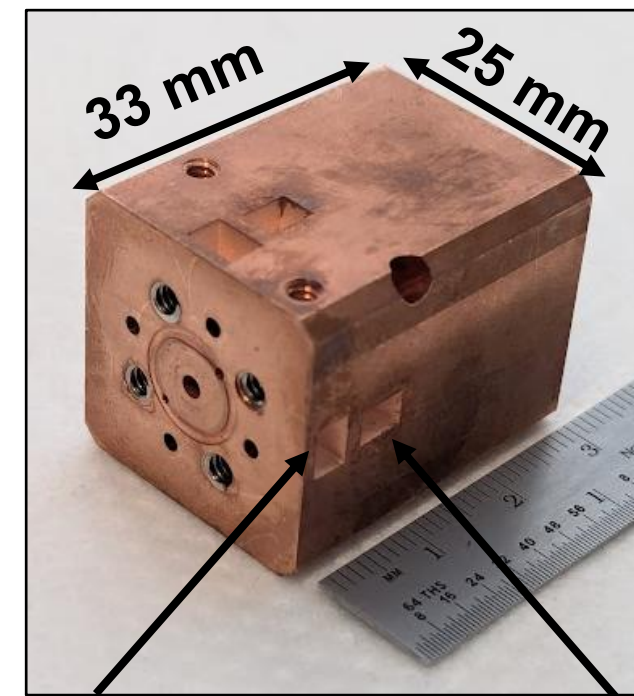
Machined Electroformed Mandrel



Leached out TS Core & Core Holder



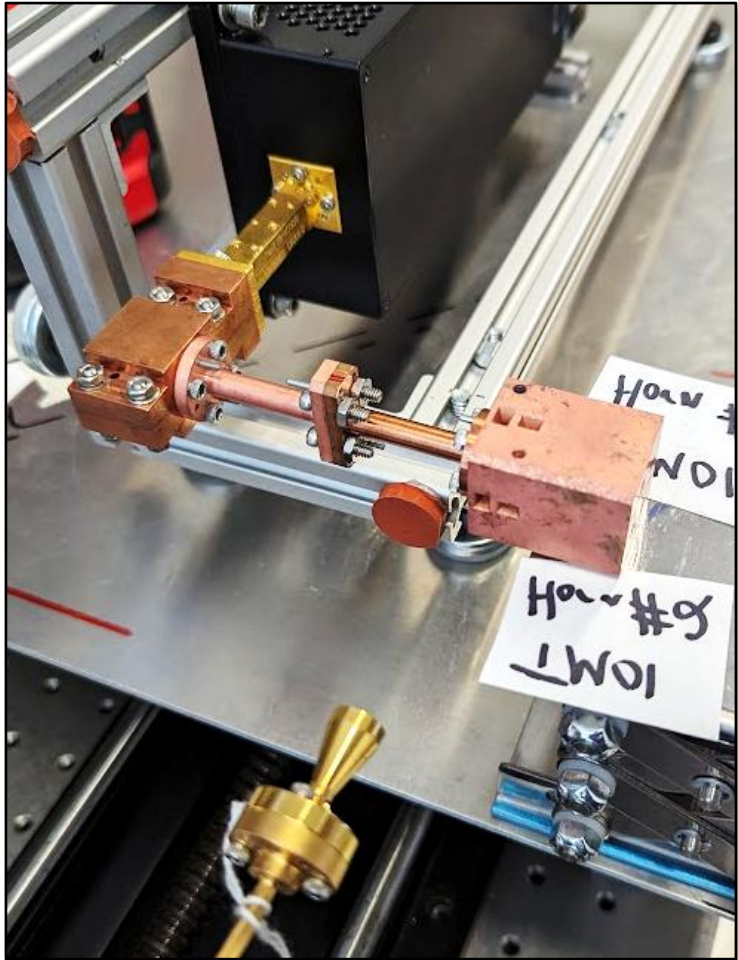
Final Machining and EDM of Horns



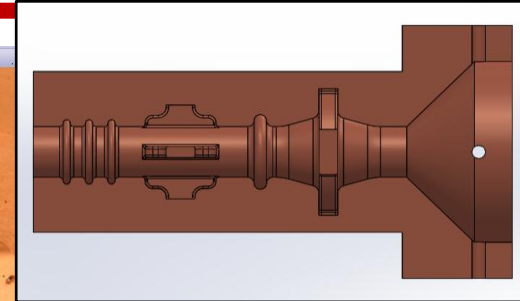
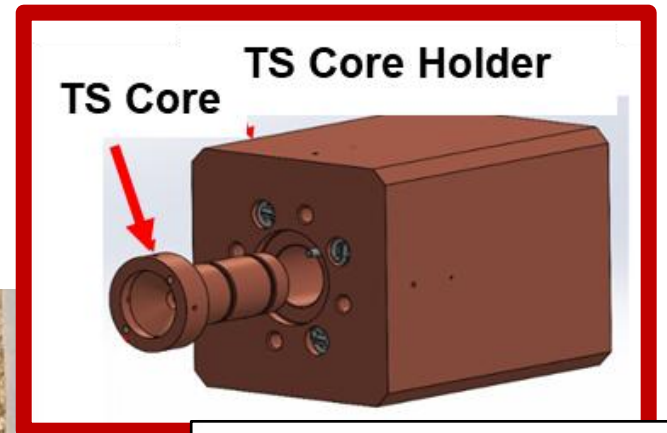
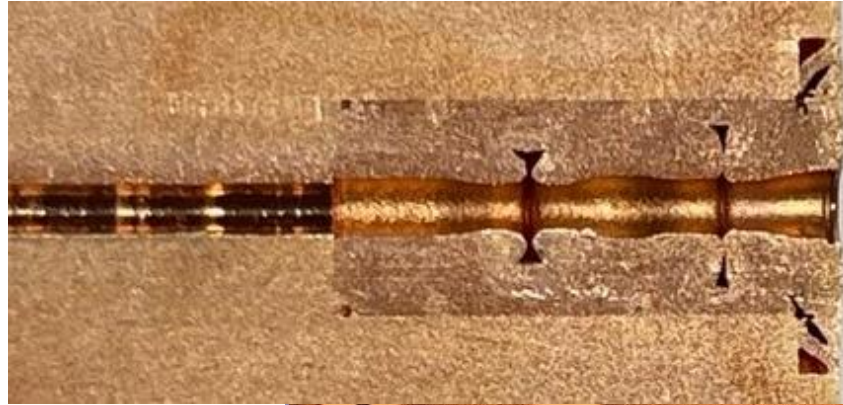
TM₀₁ Coupler
Horn Antenna,
0.72 mm × 1.78
mm

Integrated Offset Monitor
(TE₁₁) Horn Antenna,
1.10 mm × 0.45 mm

ISSUES WITH BRAZING STEP

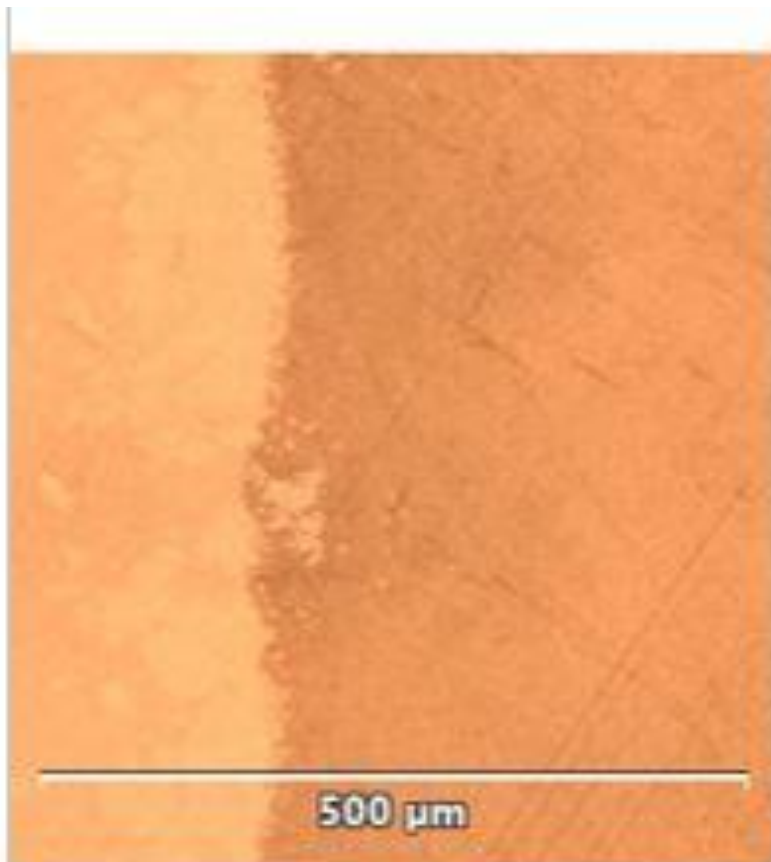


- TM_{01} Coupler signal about -3 dB less (50% of expected signal)
- TE_{11} Coupler signal about -20 dB less (1% of expected signal)



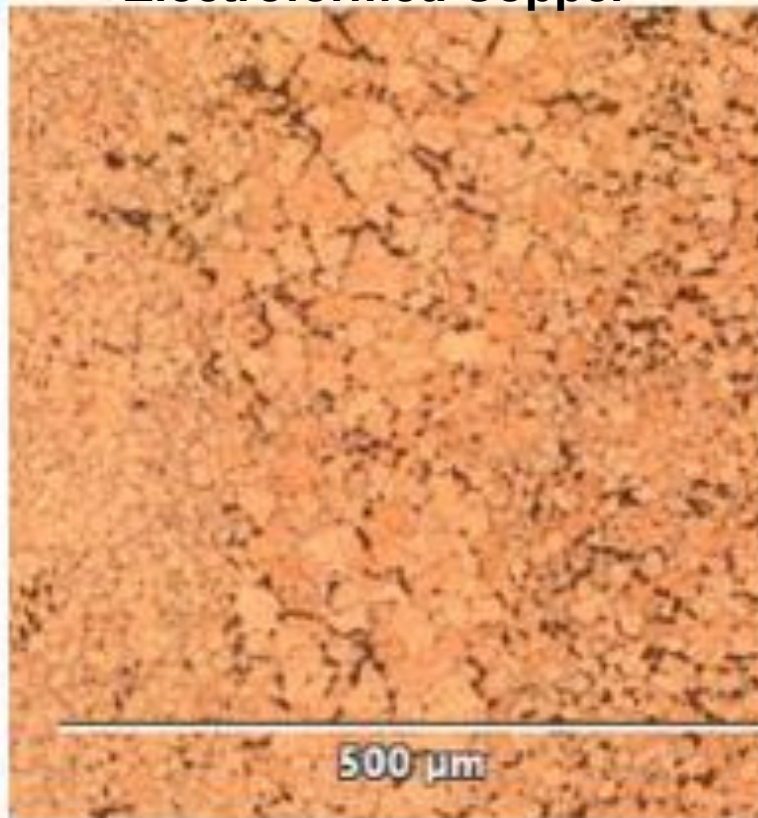
COMPARE MICROSTRUCTURES VS OFHC

Electroformed Copper



Remains uniform and featureless except for the distinct interface between dark and light regions that indicates a material change. Typical grain size is sub- μm .

Fully Annealed
Electroformed Copper



Microstructure recrystallizes and, grains grow to roughly $8\ \mu\text{m}$ in diameter with void coalescence at grain boundaries.

Oxygen-Free Copper
(UNS C10100)



Note large grains.

FUTURE GOALS

- More closely control electroforming process
 - Understand what happens during brazing
 - Increase yield strength
 - Increasing repetition rate
 - Smaller Grain size
- Measure breakdown field of electroformed copper
 - Physics poorly understood
 - Short pulses
- Simplify mode couplers (transition section) geometry
 - Fundamental mode coupler may not be necessary
 - Simplified diagnostic port geometry
 - Demonstrated good extraction efficiency experimentally
- Other materials? Stainless steel?
 - Stainless steel layer for corrugated waveguide
 - Few factors more than skin depth deposited on copper
 - Avoid different thermal expansion coeff.
 - » Steel Alloys?
 - How to deposit this layer?

CONCLUSION

- Design of complex ASTAR elements
- Fabrication of corrugated waveguides and transition section
- Tested at Brookhaven ATF
- Looking to the future for improved design and fabrication
 - Lots of lessons learned!

Thank you

Supporters

S. Baturin⁴, P. Piot⁵, W.-H. Tan⁶ (**Northern Illinois University**);
J. Byrd, D. Mills, G. Navrotski, G. Pile, S. Streiffer (**APS/ANL**)
J. Power (**HEP/ANL**)
C. Jing, A. Kanareykin (**Euclid Technology**)
M. Palmer (**ATF/BNL**)
P. Carriere (**RadiaBeam**)
G. Mouravieff, S. Oliphant (**Precision Manufacturing**)
B. Bentley, D. Leitner, K. Pearson, C. Redding (**LBNL/Engineering/Central Shop**)
J. Conway, N. Kuzmanovic, W. Toter (**ANL/Central Shop**)

4) at ITMO University, 5) at HEP/APS/ANL, 6) at SLAC

Selected Publications

Regarding Fabrication

1. A. Zholents, S. Lee, B. Popovic, M. Fedurin, K. Kusche, W. Li, A. Nassiri, A. Siy, S. Sorsher, K. Suthar, E. Trakhtenberg, and G. Waldschmidt, “*Fabrication and testing of the transition section between modules of a wakefield accelerator*”, Phys. Rev. Accel. Beams 27, 081303 (2024), <https://journals.aps.org/prab/pdf/10.1103/PhysRevAccelBeams.27.081303>
2. A. Siy, N. Behdad, J. Booske, M. Fedurin, W. Jansma, K. Kusche, S. Lee, G. Mouravieff, A. Nassiri, S. Oliphant, S. Sorsher, K. Suthar, E. Trakhtenberg, G. Waldschmidt, and A. Zholents, “*Fabrication and testing of corrugated waveguides for a collinear wakefield accelerator*”, Phys. Rev. Accel. Beams 25, 021302 (2022), <https://link.aps.org/doi/10.1103/PhysRevAccelBeams.25.021302>

Regarding Quadrupole Wiggler

1. M. Qian, M. Kasa, J. Xu, S. Doran, S. Lee, S. Sorsher, N. Strelnikov, E. Trakhtenberg, and A. Zholents, “*Quadrupole wiggler for a collinear wakefield accelerator*”, Phys. Rev. Accel. Beams 28, 012401 (2025), <https://doi.org/10.1103/PhysRevAccelBeams.28.012401>

Overview

Publications

1. A. Zholents, S. Baturin, S. Doran, W. Jansma, et al., 18 coauthors, “*A high repetition rate millimeter wavelength accelerator for an X-ray free-electron laser*”, Journal of Instrumentation, JINST 20 P01023 (2025), <https://doi.org/10.1088/1748-0221/20/01/P01023>

Theory

1. S. Baturin, A. Zholents. “*Upper Limit for the Acceleration Gradient in the Collinear Wake Field Accelerator as a Function of the Transformer Ratio*”, Phys. Rev. Acc. and Beams 20, no. 6, June 19, 061302 (2017).
2. S. Baturin, A. Zholents. “*Stability condition for the drive bunch in a collinear wakefield accelerator*”, Phys. Rev. Acc. and Beams 21, 031301, (2018).

Design

1. W. Jansma, S. Sorsher, K. Suthar, E. Trakhtenberg, A. Zholents, “*Metrology in the R&D for the high repetition rate multi-user x-ray free-electron laser*”, The Journal of CMSC (Autumn 2019).
2. Wei Hou Tan, P. Piot, A. Zholents, “*Formation of temporally shaped electron bunches for beam-driven collinear wakefield accelerators*”, Phys. Rev. Accel. Beams, 24, 051303(2021).
3. K. Suthar, E. Trakhtenberg, S. Sorsher, and A. Zholents, “*Vacuum analysis of a corrugated waveguide wakefield accelerator*”, Mech. Eng. Design of Synchrotron Radiat. Equip. and Instrum., MEDSI2020, Chicago, IL, p.160, 2021, doi:10.18429/JACoW-MEDSI2020-TUPB07 .
4. K. Suthar, A. Siy, G. Waldschmidt, S. Lee, E. Trakhtenberg, S. Sorsher, and A. Zholents, “*Determination of maximum repetition rate of a corrugated-waveguide-based wakefield accelerator*”, Mech. Eng. Design of Synchrotron Radiat. Equip. and Instrum., MEDSI2020, Chicago, IL, p.336, 2021, doi:10.18429/JACoW-MEDSI2020-THIQ02.

Design

1. S. Lee, S. Doran, W. Jansma, A. Siy, S. Sorsher, K. Suthar, E. Trakhtenberg, G. Waldschmidt, and A. Zholents, “*Mechanical design of a compact collinear wakefield accelerator*”, Mech. Eng. Design of Synchrotron Radiat. Equip. and Instrum., MEDSI2020, Chicago, IL, p.276, 2021, doi:10.18429/JACoW-MEDSI2020-WEPB05.
2. S. Lee, W. Jansma, A. Siy, S. Sorsher, K. Suthar, E. Trakhtenberg, G. Waldschmidt, A. Zholents, “*Design and fabrication challenges of transition section for the CWA module*”, Mech. Eng. Design of Synchrotron Radiat. Equip. and Instrum., MEDSI2020, Chicago, IL, p.273, 2021, doi:10.18429/JACoW-MEDSI2020-WEPB04.
7. K. Suthar, G. Navrotski, P. Carriere, and A. Zholents, “*Study of copper microstructure produced by electroforming for the 180-GHz frequency corrugated waveguide*”, Mech. Eng. Design of Synchrotron Radiat. Equip. and Instrum., MEDSI2020, Chicago, IL, p.178, 2021, doi:10.18429/JACoW-MEDSI2020-TUPC01.
8. B. Popovic, S. Lee, E. Trakhtenberg, K. Suthar, A. Siy, G. Waldschmidt, S. Sorsher, A. Zholents, “*Design of miniature waveguides and diamond window assembly for rf extraction and vacuum isolation for the CWA*”, Mech. Eng. Design of Synchrotron Radiat. Equip. and Instrum., MEDSI2020, Chicago, IL, p.156, 2021, doi:10.18429/JACoW-MEDSI2020-TUPB06.
9. A. Siy, N. Behdad, J. Booske, G. Waldschmidt, and A. Zholents, “*Design of a cylindrical corrugated waveguide for a collinear wakefield accelerator*”, Phys. Rev. Accel. Beams 25, 121601(2022).
10. A. Siy, N. Behdad, J. Booske, G. Waldschmidt, and A. Zholents, “*Electromagnetic design of the transition section between modules of a wakefield accelerator*”, Phys. Rev. Accel. Beams 26, 012802(2023).
11. J. Xu, M. Qian, and A. Zholents, “*A force-neutral adjustable phase undulator for a compact x-ray FEL*”, in: Proceedings of the IPAC 2023, Venice, Italy, p.1754, (2023); Pending patent application.

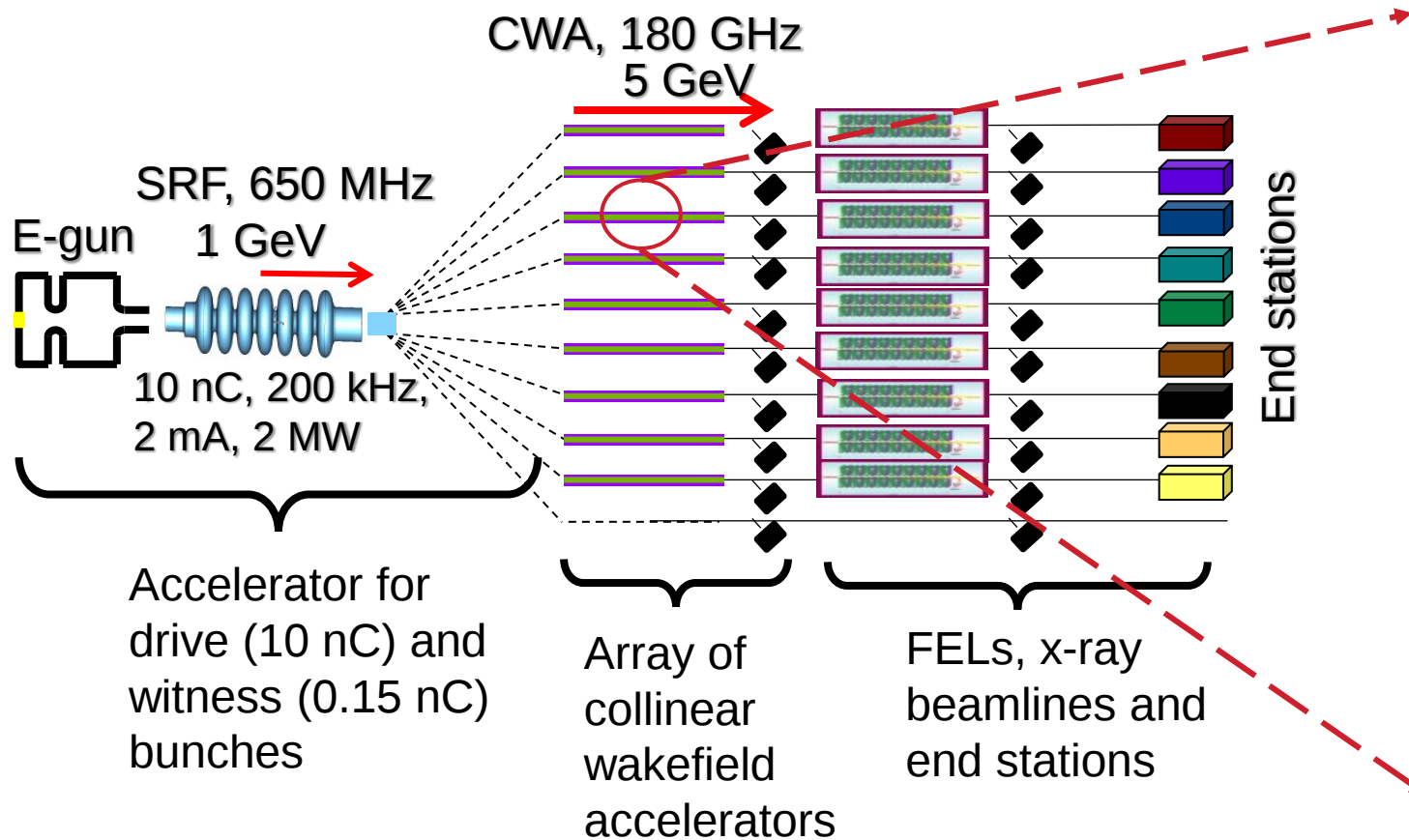
Publications

Testing

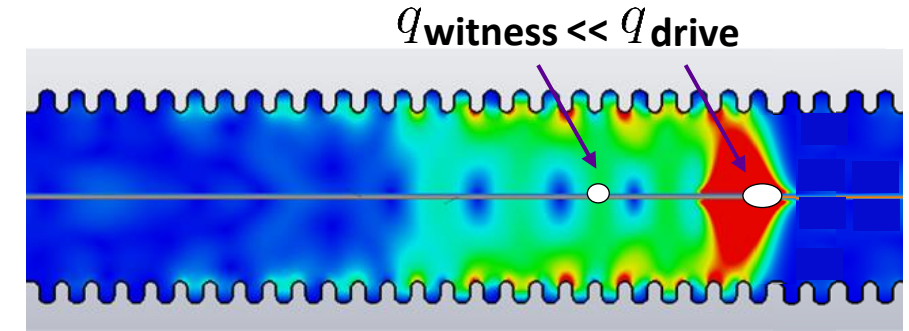
1. A. Zholents, S. Lee, B. Popovic, M. Fedurin, K. Kusche, W. Li, A. Nassiri, A. Siy, S. Sorsher, K. Suthar, E. Trakhtenberg, and G. Waldschmidt, “*Fabrication and testing of the transition section between modules of a wakefield accelerator*”, Phys. Rev. Accel. Beams 27, 081303 (2024), <https://link.aps.org/doi/10.1103/PhysRevAccelBeams.27.081303>
2. A. Siy, N. Behdad, J. Booske, M. Fedurin, W. Jansma, K. Kusche, S. Lee, G. Mouravieff, A. Nassiri, S. Oliphant, S. Sorsher, K. Suthar, E. Trakhtenberg, G. Waldschmidt, and A. Zholents, “*Fabrication and testing of corrugated waveguides for a collinear wakefield accelerator*”, Phys. Rev. Accel. Beams 25, 021302 (2022), <https://link.aps.org/doi/10.1103/PhysRevAccelBeams.25.021302>
3. M. Qian, M. Kasa, J. Xu, S. Doran, S. Lee, S. Sorsher, N. Strelnikov, E. Trakhtenberg, and A. Zholents, “*Quadrupole wiggler for a collinear wakefield accelerator*”, Phys. Rev. Accel. Beams 28, 012401 (2025), <https://doi.org/10.1103/PhysRevAccelBeams.28.012401>

MOTIVATION

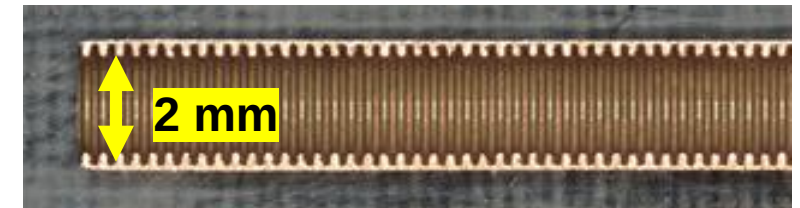
A multi-user FEL facility based on the array of Collinear Wakefield Accelerators



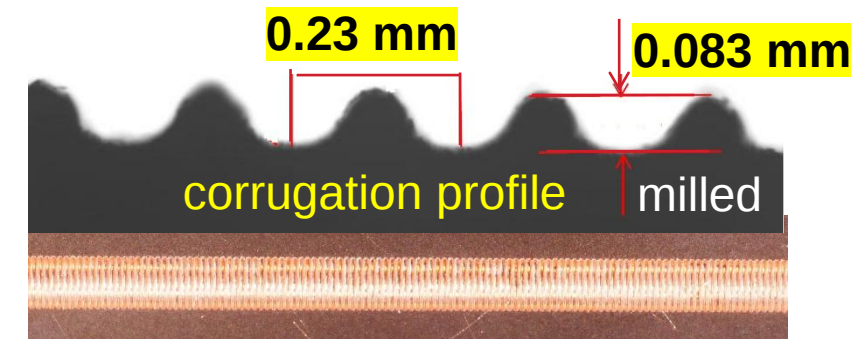
- High bunch repetition rate operation is the essential goal
- High wall plug power efficiency
 - CWAs do not need electrical power
 - Undulators do not need electrical power



G. A. Voss and T. Weiland, DESY M-82-10, 1982



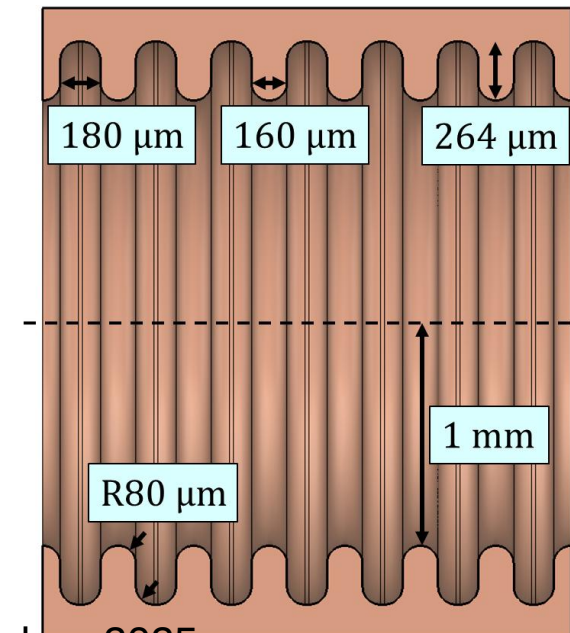
A. Siy *et al.*, PRAB, December, 2022



K. Bane *et al.*, NIM A, 2017
(photo: courtesy G. Bowden)

CORRUGATED WAVEGUIDE DESIGN

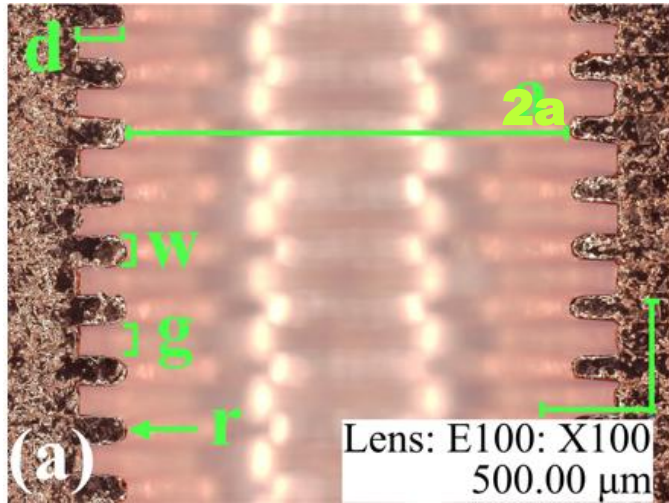
- Maximize
 - Loss factor
 - Group velocity
- Minimize
 - Peak surface fields
 - Power dissipation on the walls
 - Transient temperature rise of surface
 - High order modes
- Simplify fabrication



DIE STAMPING

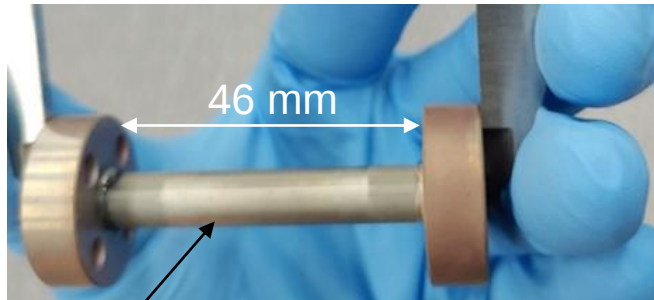
(This slide is based on recent publication H. Kong *et al.*, Scientific Reports, **2023**)

Made in Pohang Accelerator Laboratory



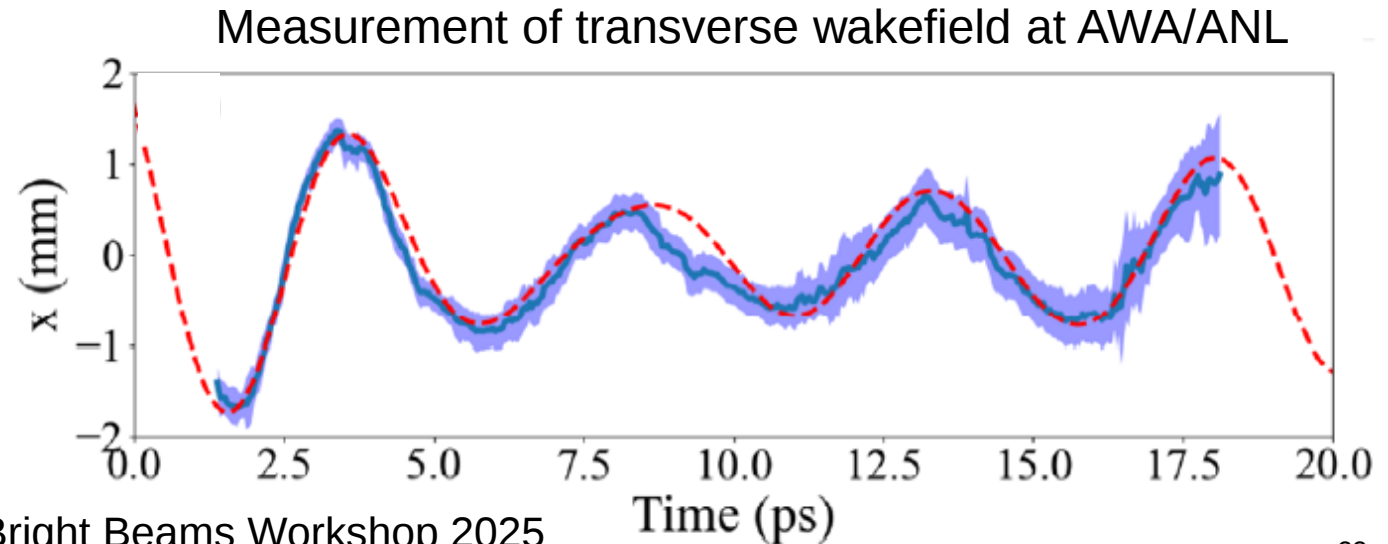
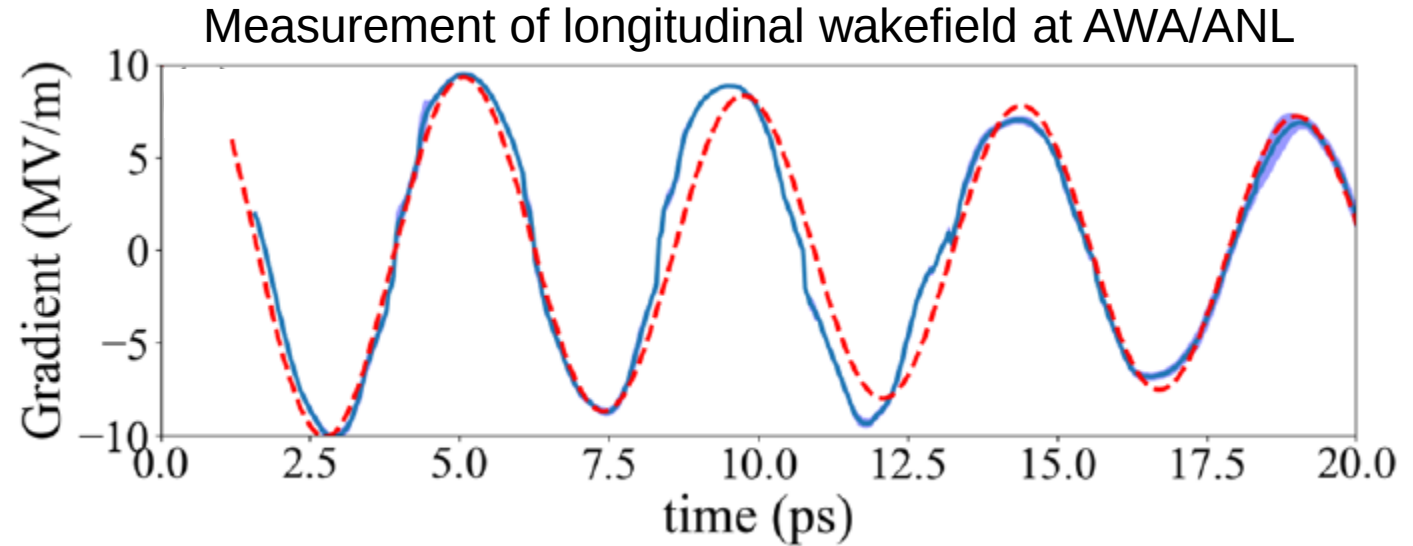
$a = 1.02 \text{ mm}$
 $w = 130 \mu\text{m}$
 $g = 130 \mu\text{m}$
 $d = 200 \mu\text{m}$
 $r = 65 \mu\text{m}$

Diffusion bonding of stamped discs



SS jacket, 8 mm OD

U.S. DEPARTMENT OF ENERGY
Argonne National Laboratory is a
U.S. Department of Energy laboratory
managed by UChicago Argonne, LLC
(photos, courtesy H. Kong)

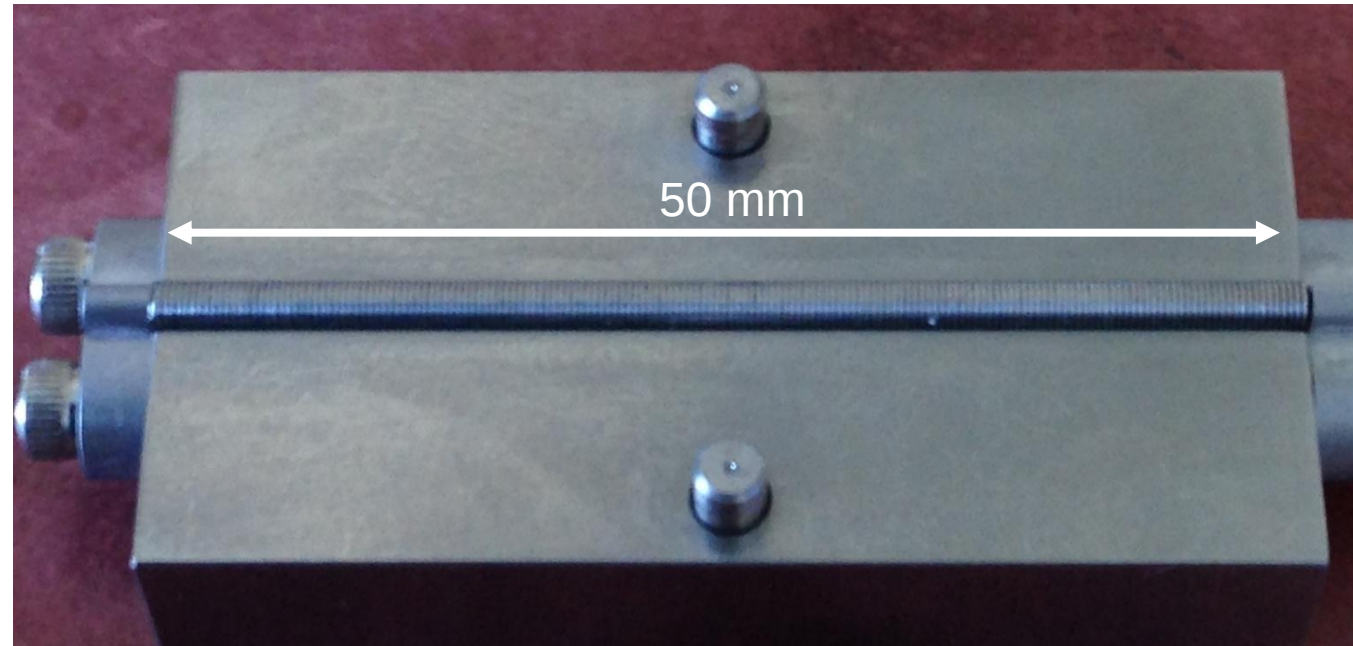


B. Popovic: Bright Beams Workshop 2025

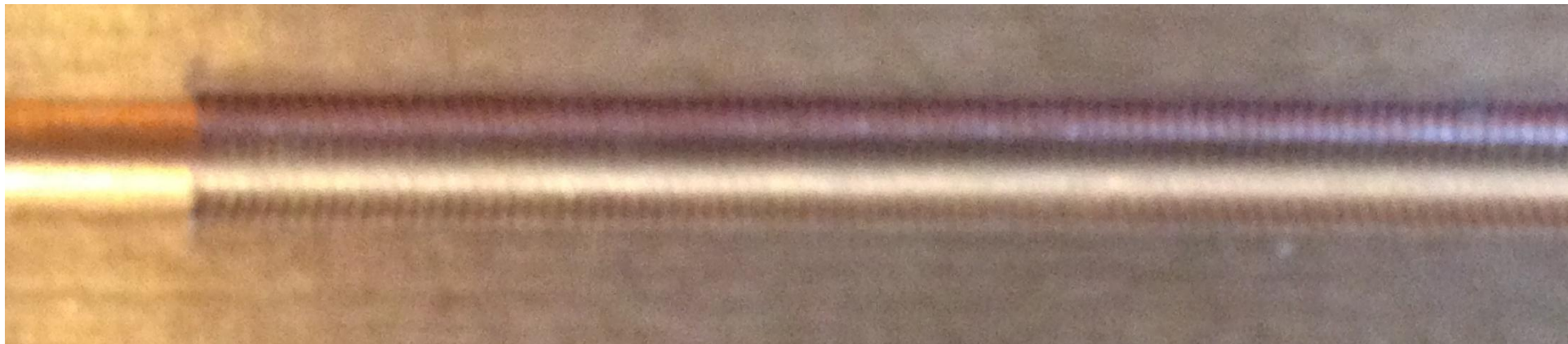
IMPRESSION (COLD FORMING)

Impression of a stainless steel die into a machined, semi-circular groove in a copper plate

Stainless
steel die

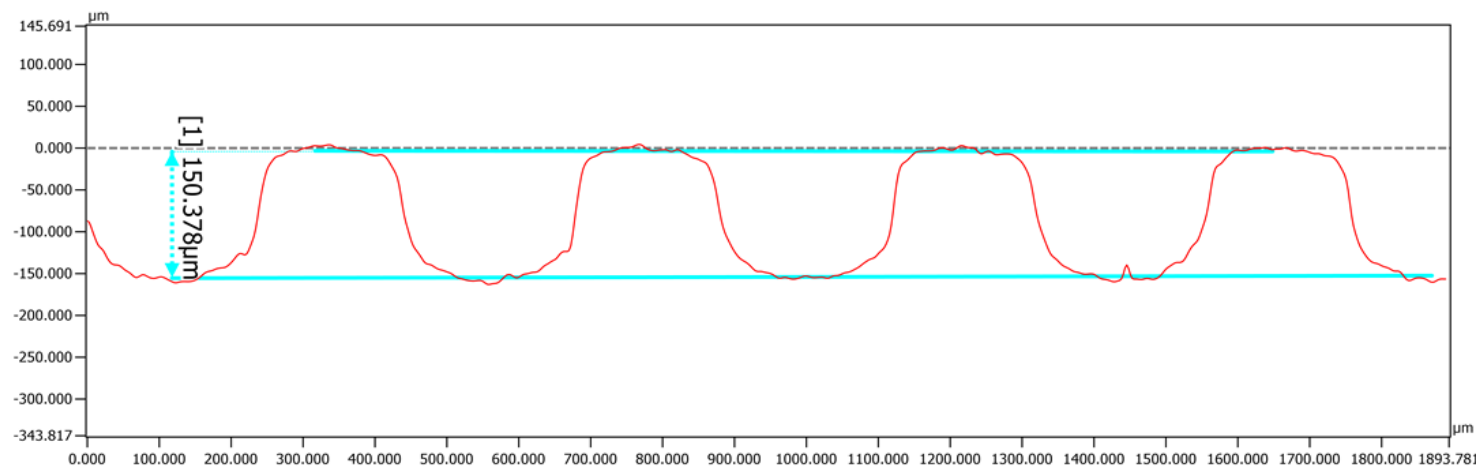
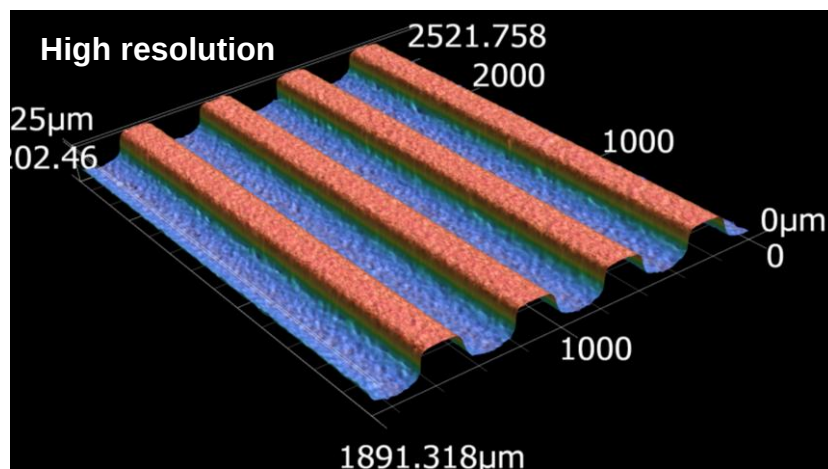
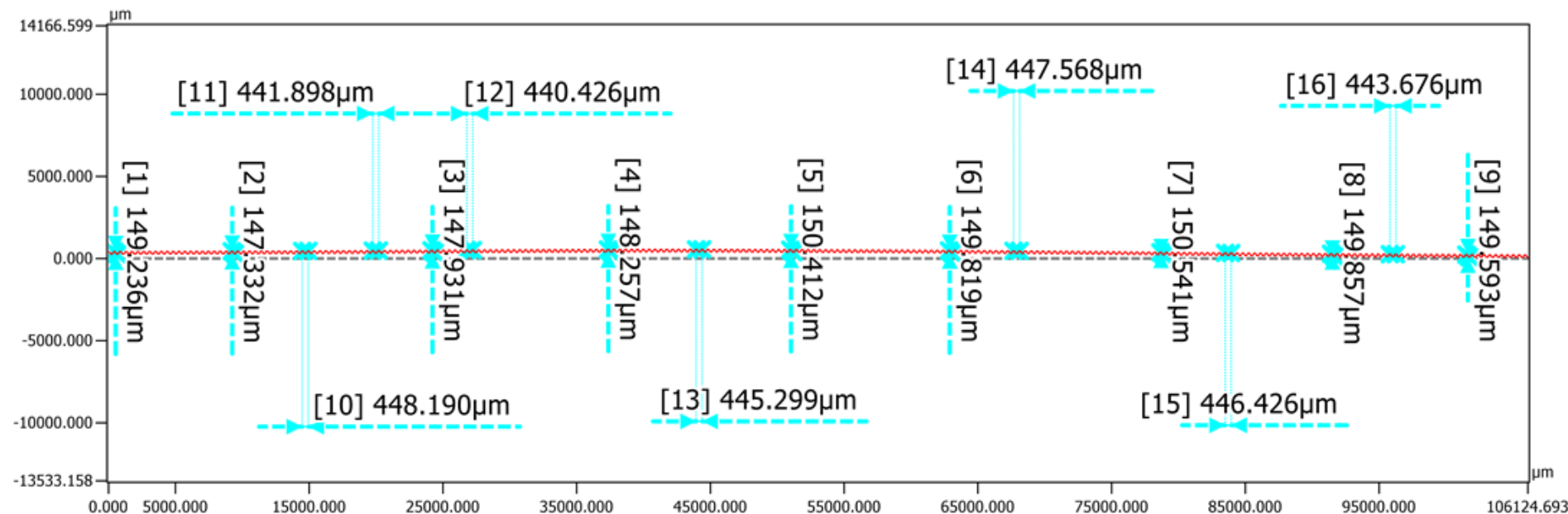
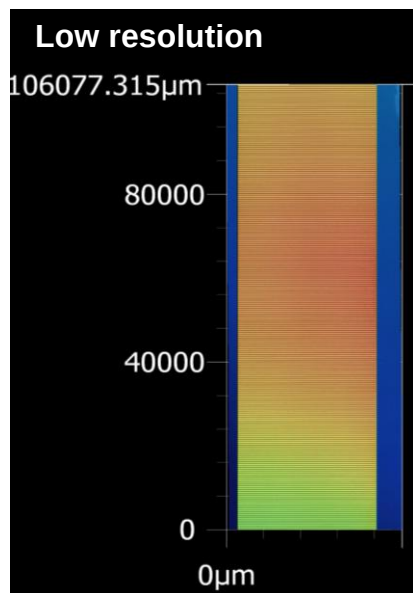


Copper
sample
after
pressing



Can be used for shallow grooves

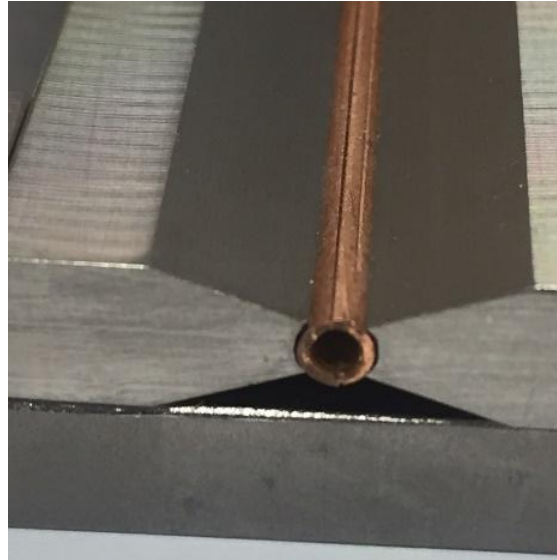
FLAT PLATE



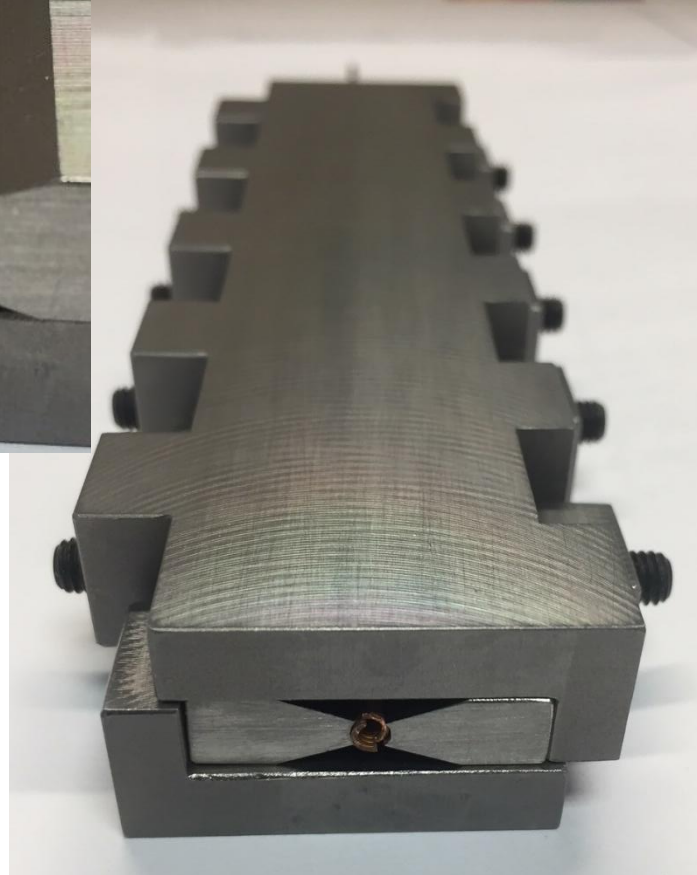
FORMING ROUND CORRUGATED STRUCTURE



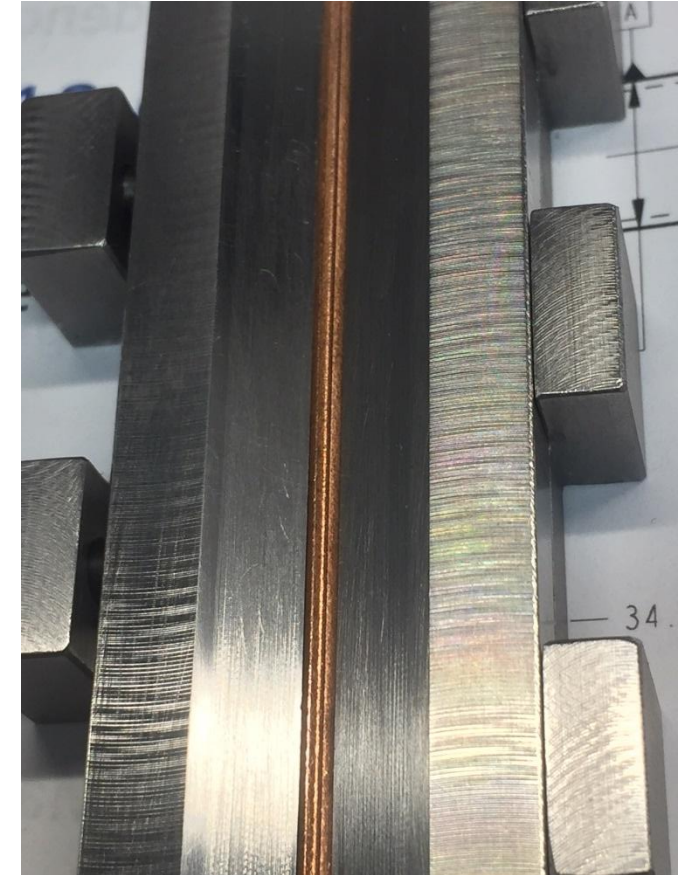
Bending



Joining

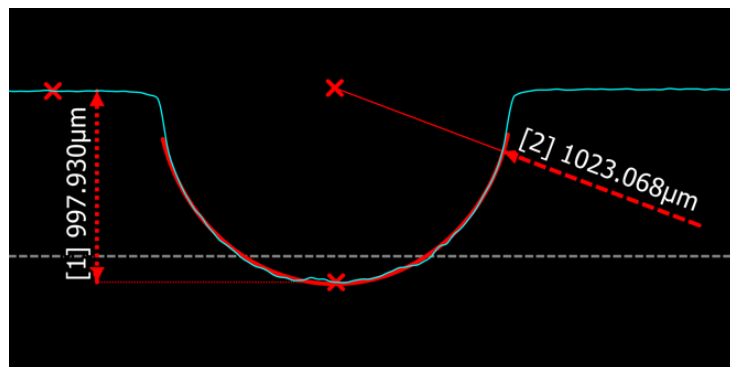
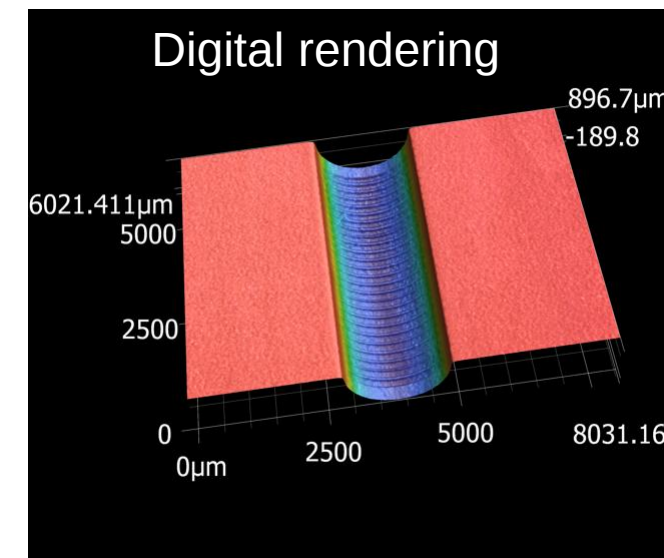
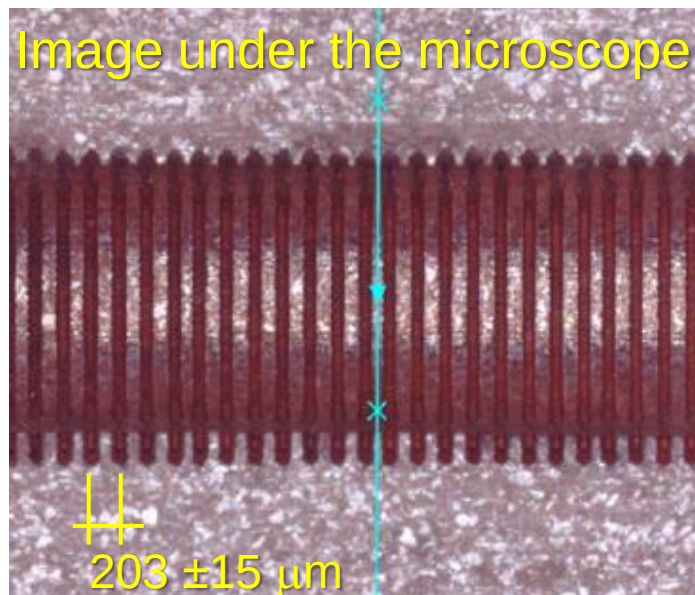
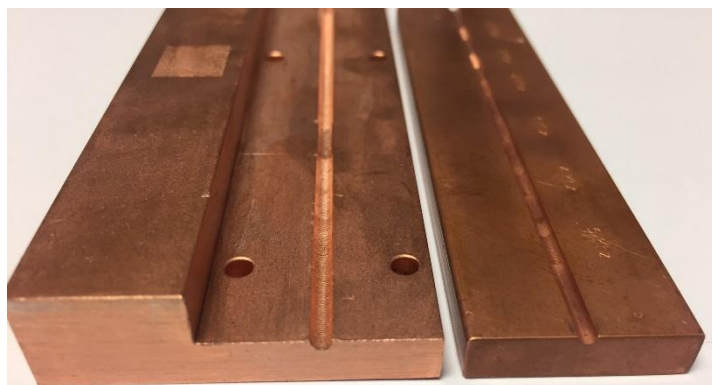


Holding

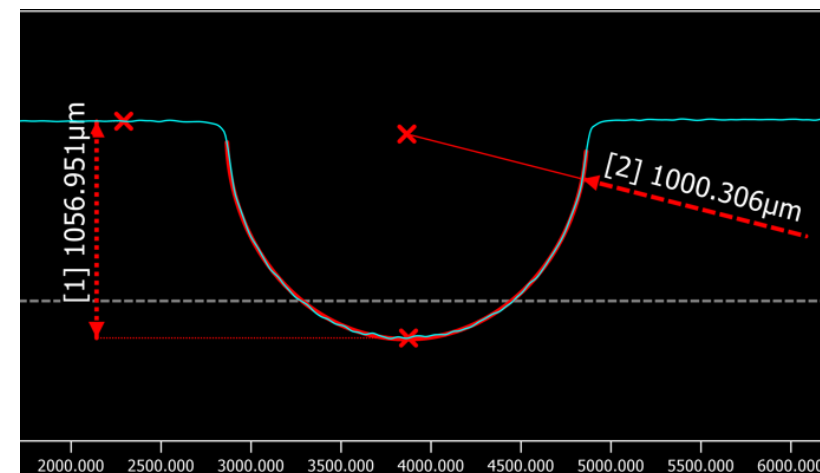


Welding
laser/e-beam

GROOVE



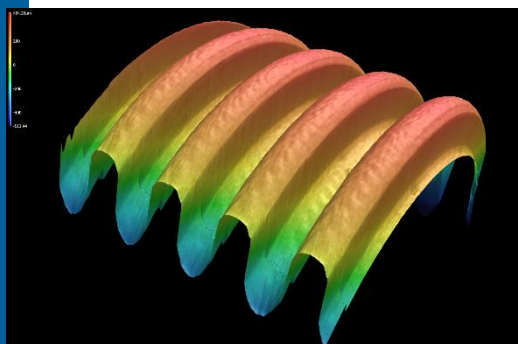
Cross-sectional profile through a raised tooth



Cross-sectional profile through a groove

ELECTROFORMING CIRCULAR CORRUGATED WAVEGUIDE

Aluminum mandrel production



High-Quality
Surface
Finish

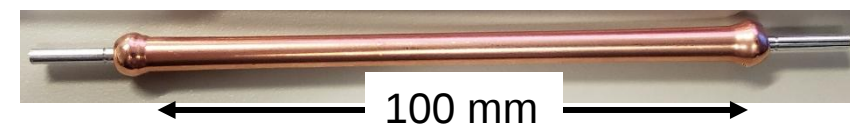
Proprietary micro-machining process
Tooth Height $252.7\text{ }\mu\text{m}$; error $1.5\text{ }\mu\text{m RMS}$
Tooth Width $175.9\text{ }\mu\text{m}$; error $2.0\text{ }\mu\text{m RMS}$

Mandrel inspection and straightening



using optical comparator

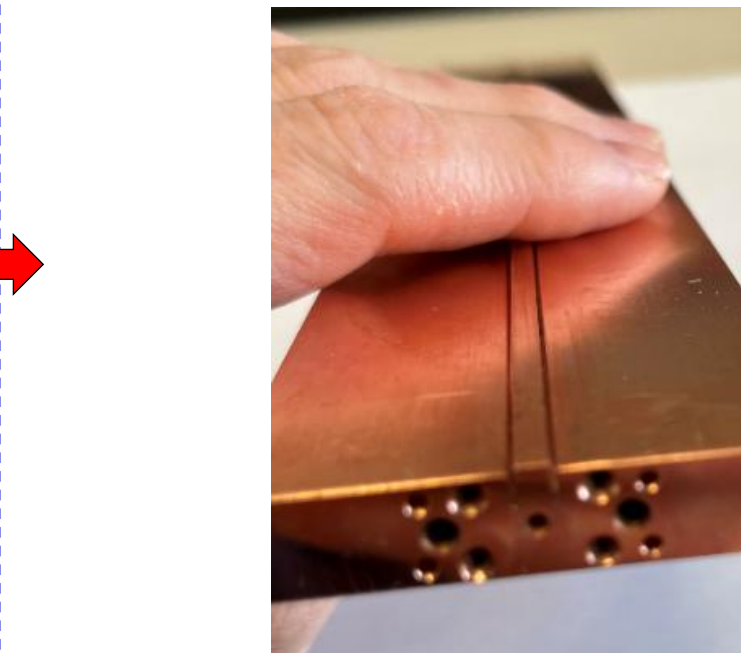
Electroforming



EDM of outside diameter OD



Precision cut of edges



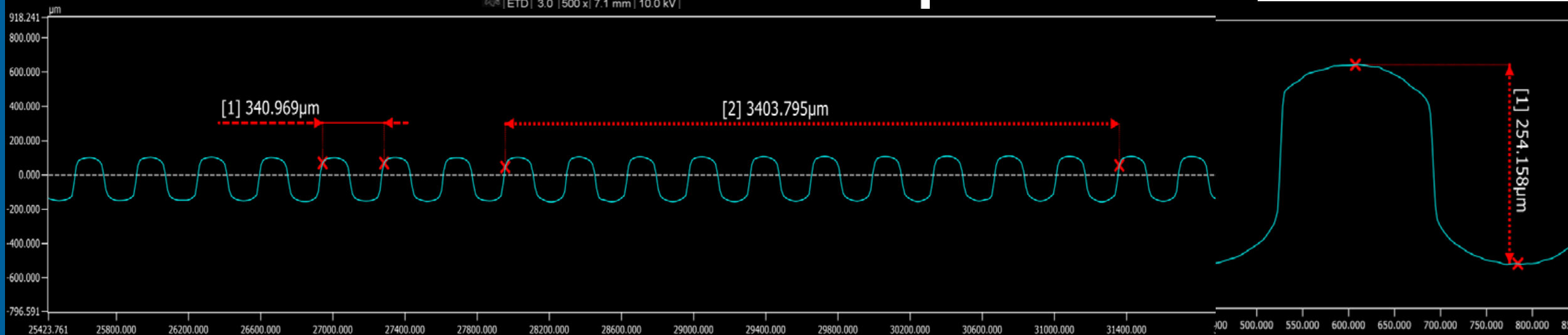
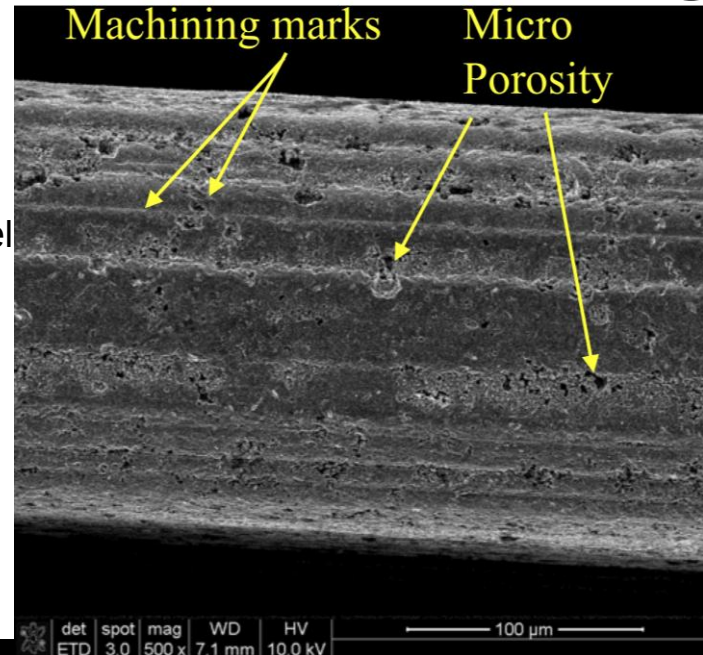
chamber with five 10-cm long tubes after
brazing (currently use three)

Mandrel inspection and straightening

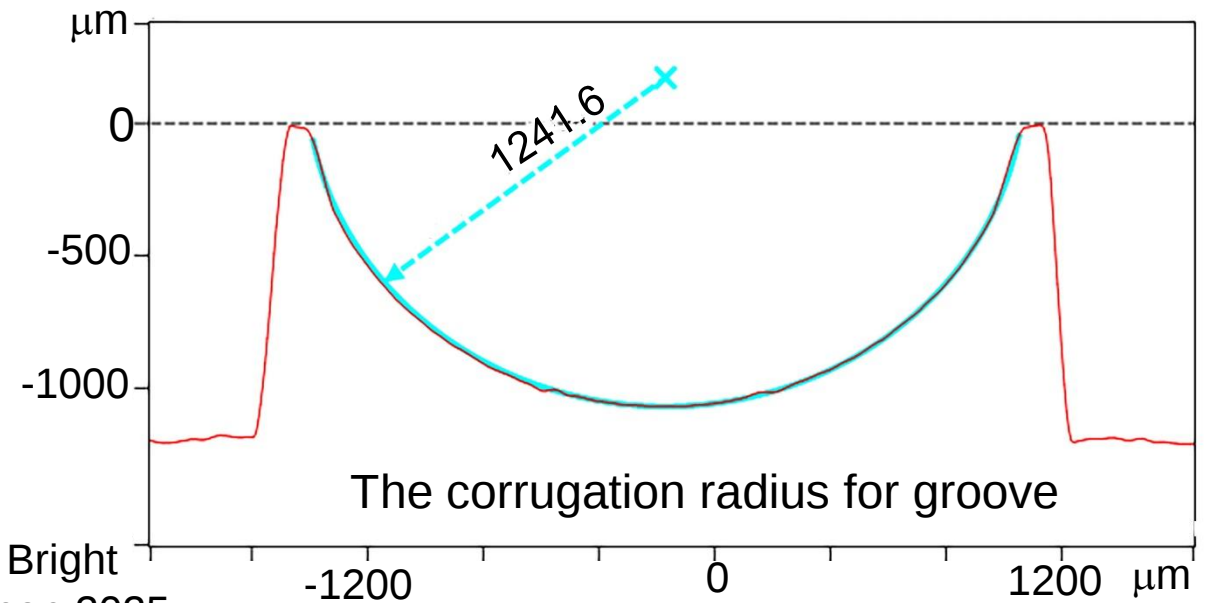
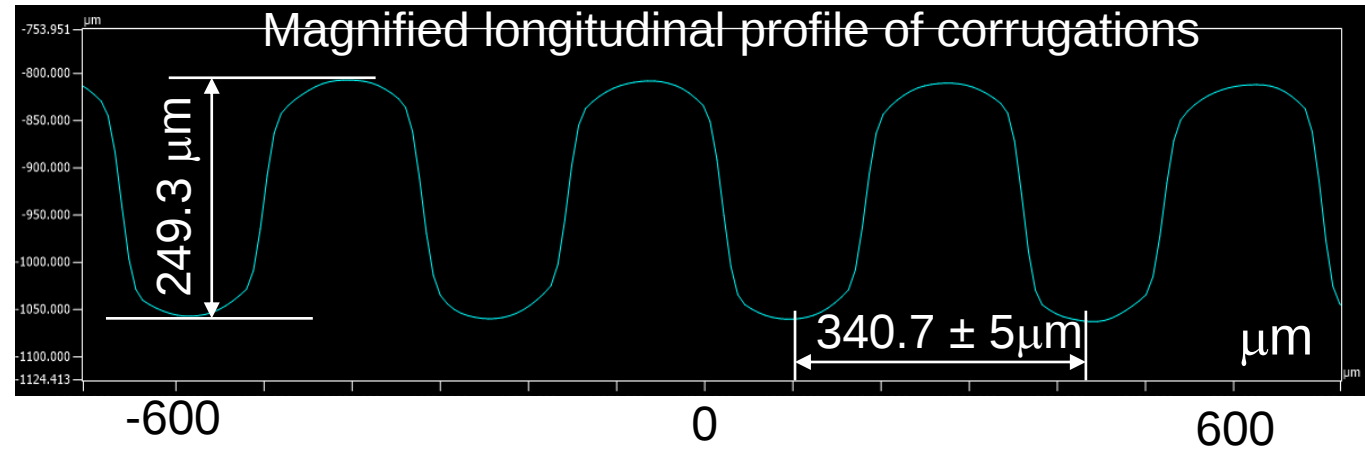
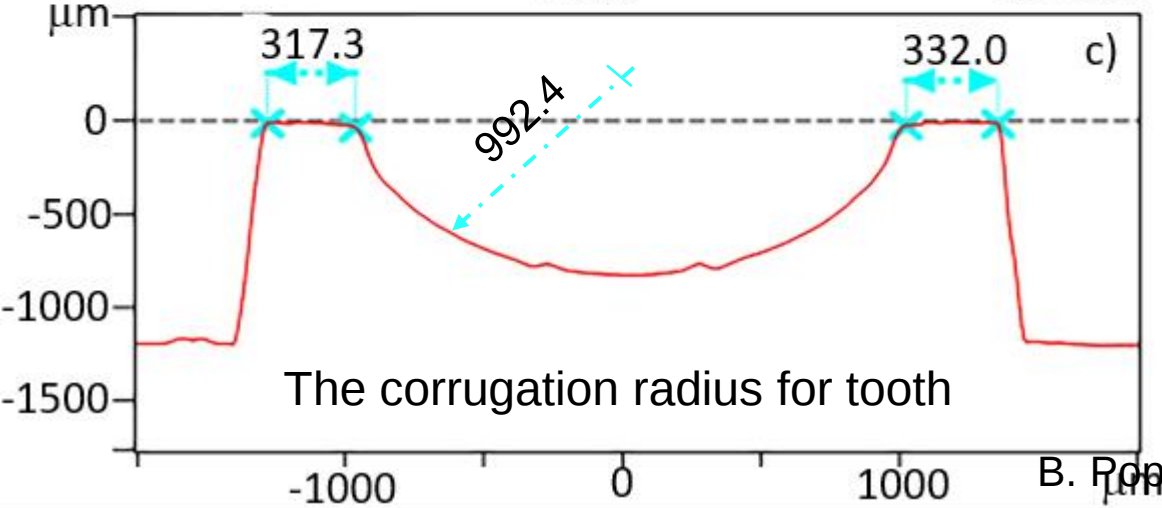
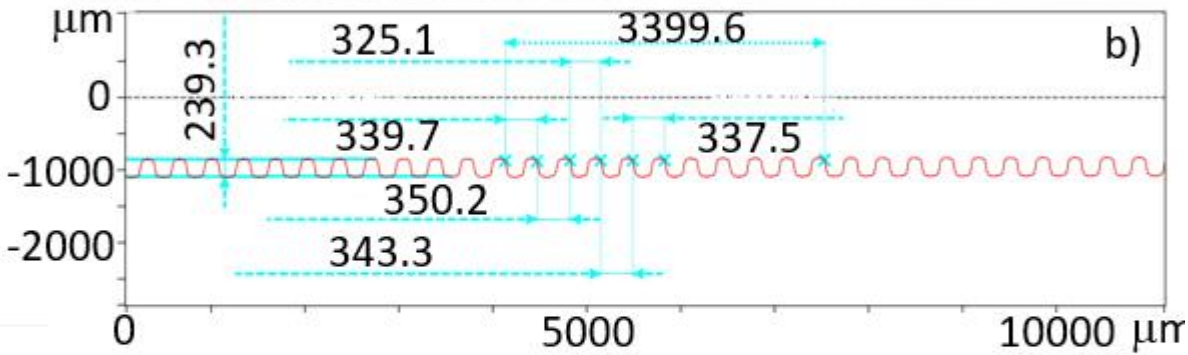
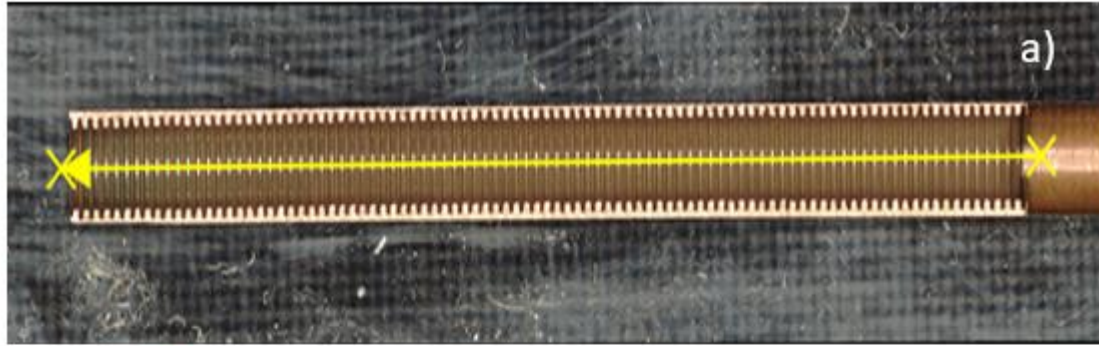
Inspect for mandrel defects.

Mandrel defects will imprint onto the electroformed structure inner surface. Machining marks on the aluminum mandrel inadvertent scratches from handling or shallow pits created during cleaning form the template that is duplicated during the electroforming process.

Mandrel measurements indicate excellent fabrication quality

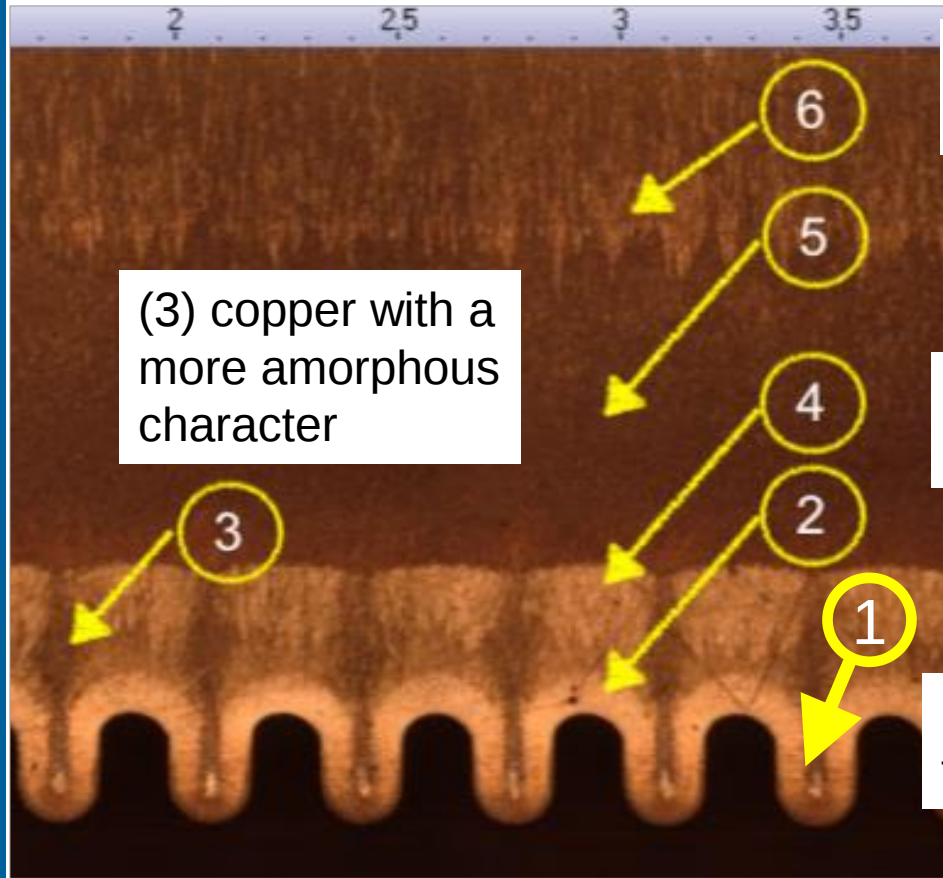


ELECTROFORMING CIRCULAR CORRUGATED WAVEGUIDE (2)



MICROSTRUCTURE OF CORRUGATIONS

- Improved prototype microstructure



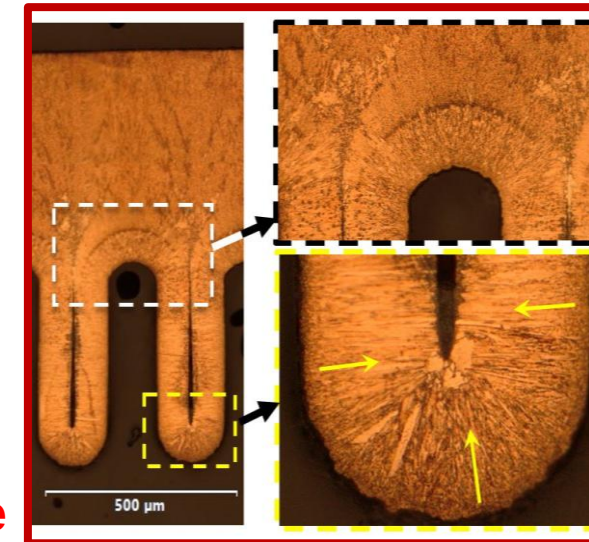
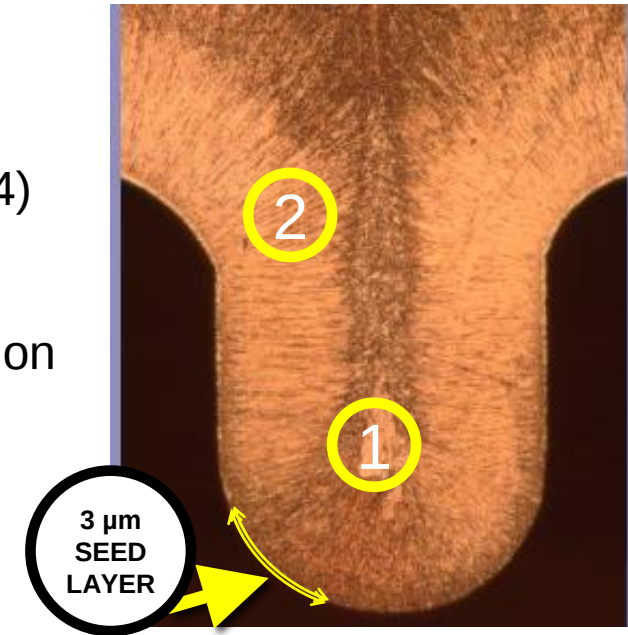
(6) layer with the same nascent recrystallization characteristics as region (4)

(5) the darkest, smallest grain, most amorphous, and the highest hardness region

(4) layer with a degree of recrystallization preferentially oriented away from (2)

(2) layer highly elongated layer of single crystal follow the seed layer contour

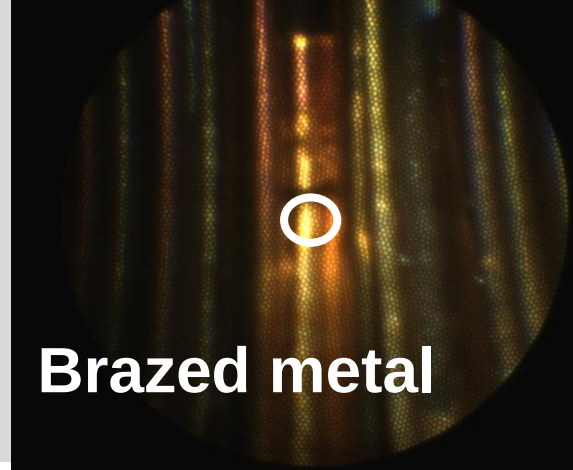
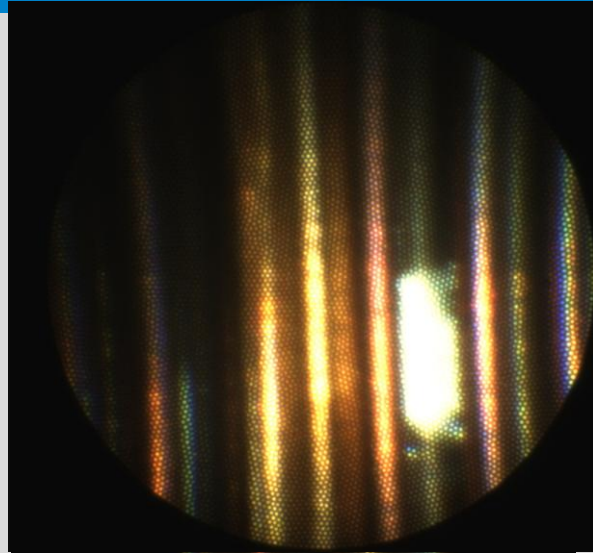
(1) small cluster of large equiaxed grains at the apex of each corrugation.



Test Sample

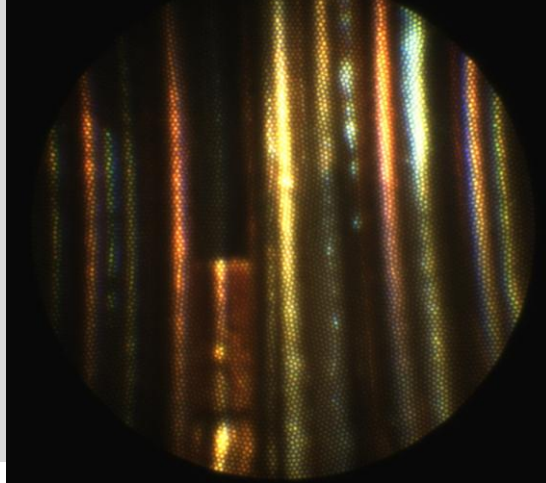
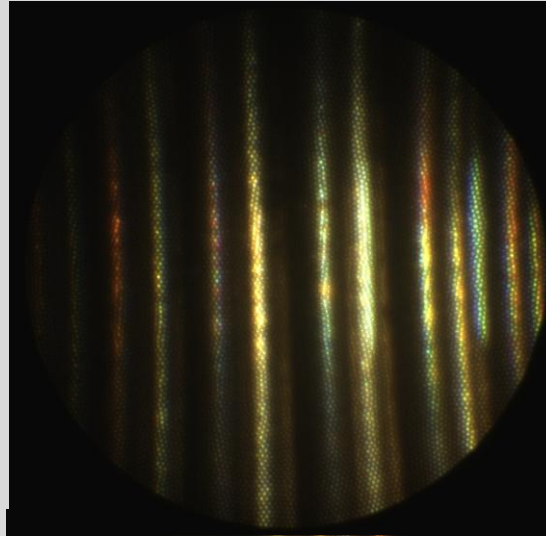
BORESCOPE INSPECTION OF CORRUGATIONS³¹

Joint

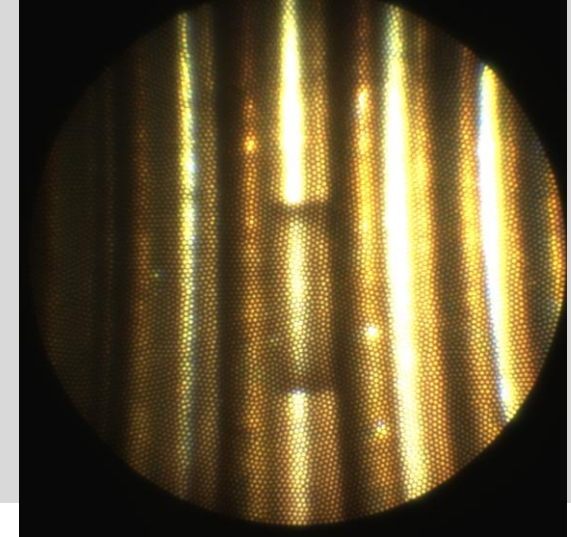
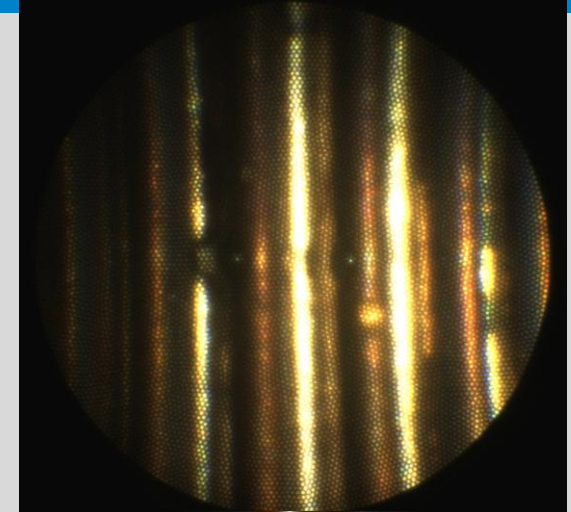


Brazed metal

Discoloration



Some Features

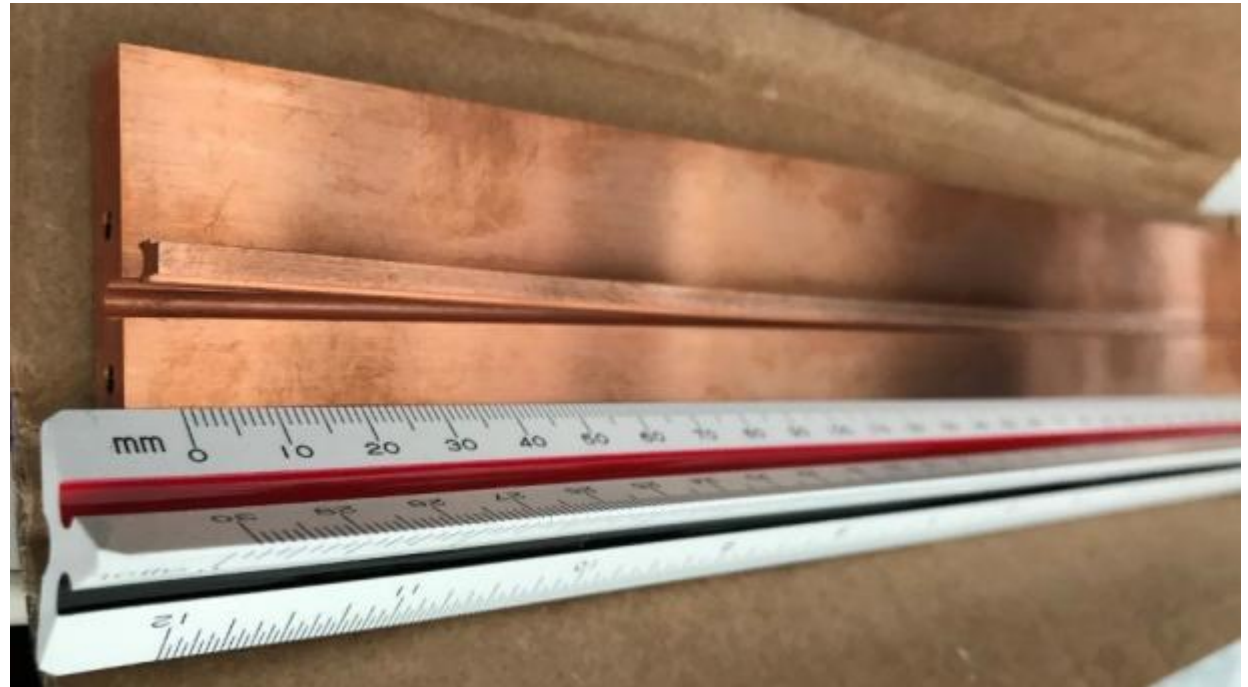


SELECTION OF WAVEGUIDES FOR BRAZING

- Check Diameters
- Cleaning before brazing

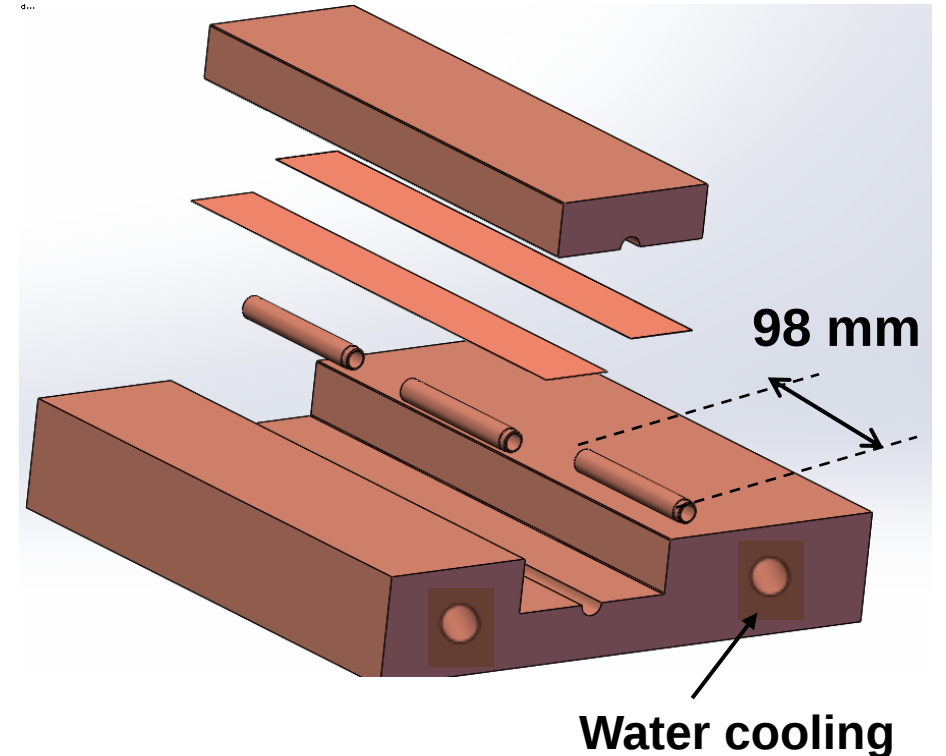
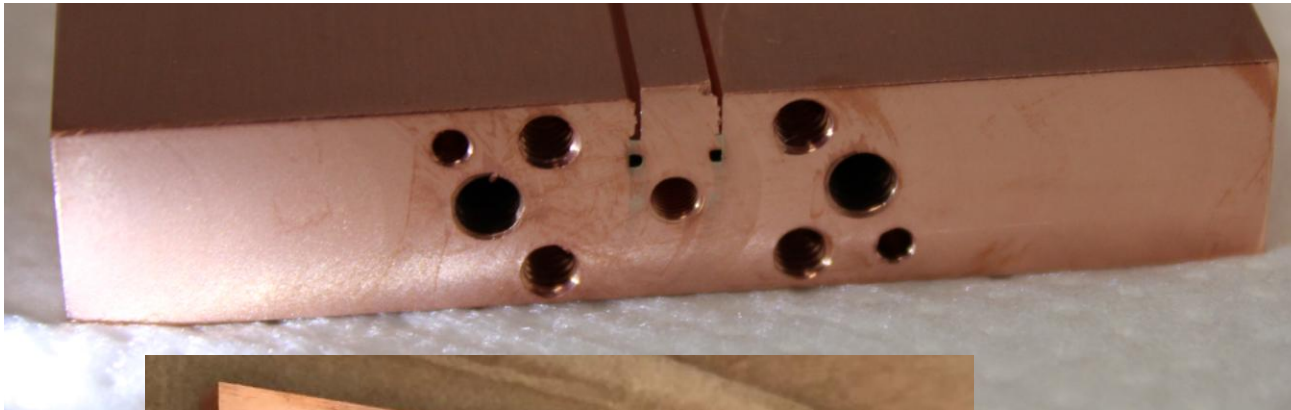
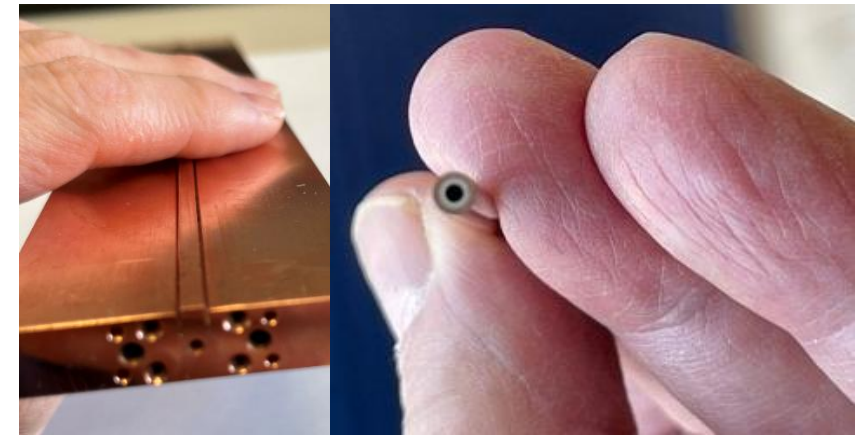


Figure 1: Twelve(12) waveguides in transport tubes, as received from Servometer.



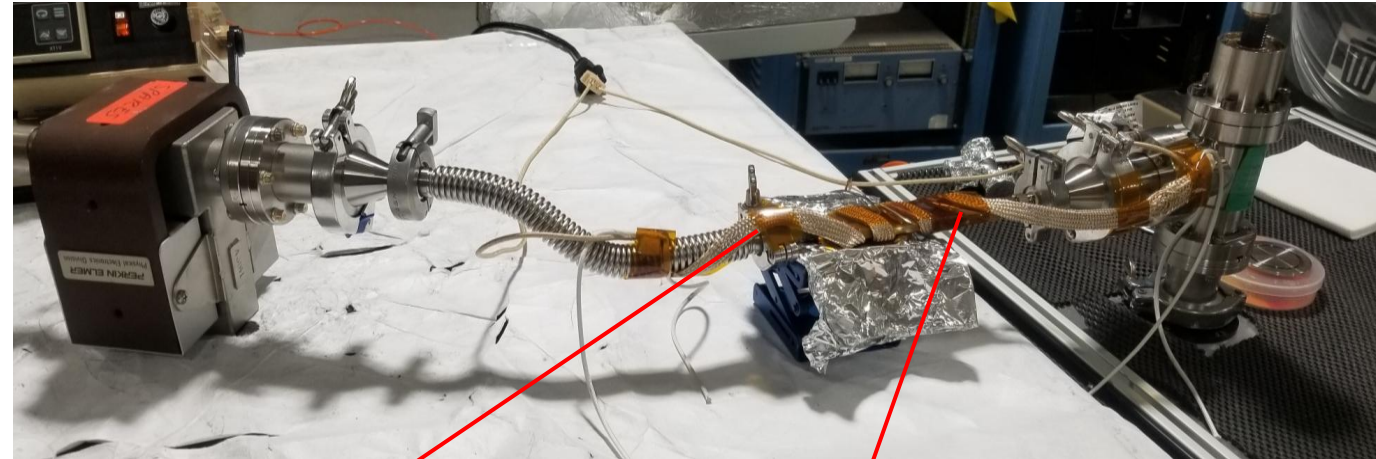
CHAMBER (300 MILLIMETERS)

Three 10-cm long tubes after brazing:
low temperature brazing at 360 °C

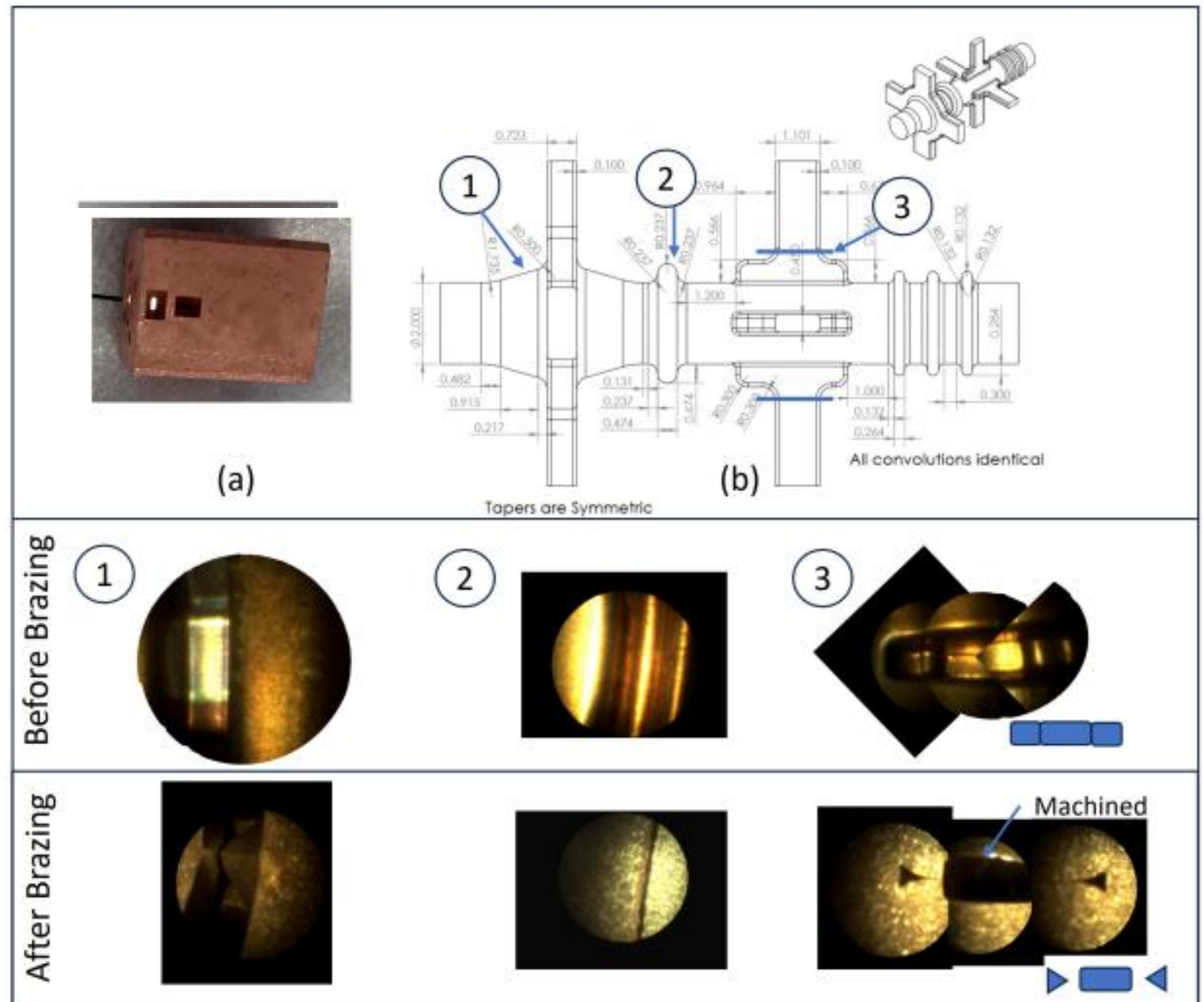
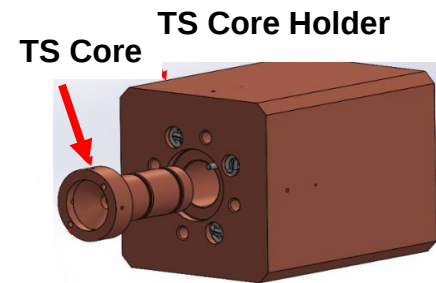


VACUUM TESTING OF 152MM TEST PIECE

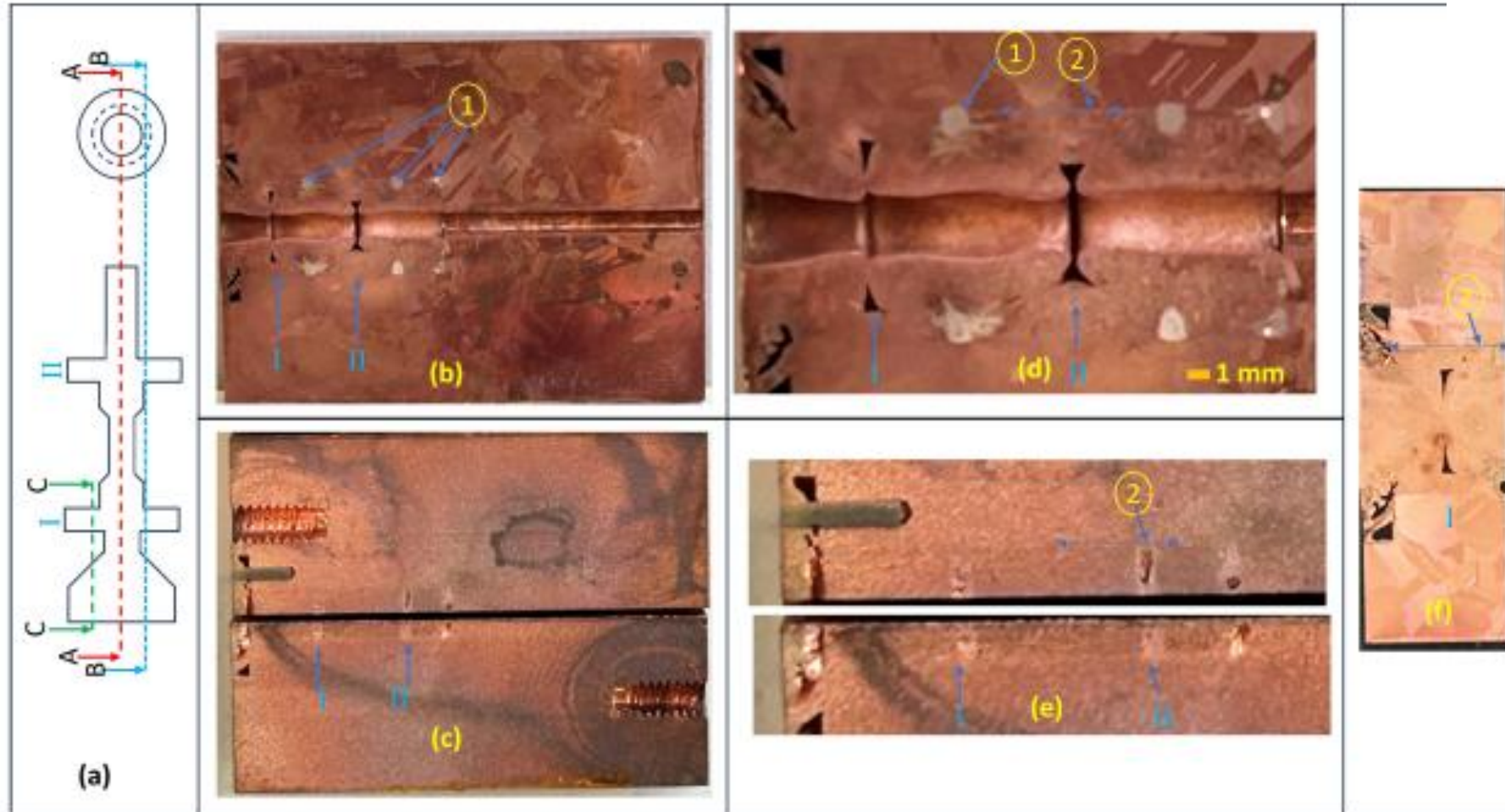
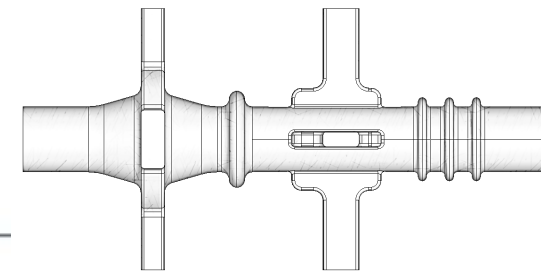
- Smooth Tube
 - $8.5\text{E-}8$ Torr after bakeout
- Emittance beam grow due to multiple Coulomb scatter of electrons is negligible at $4\text{E-}7$ Torr
 - 10^{-7} mm*mrad
 - This vacuum is acceptable if permitted by electrical breakdown



ISSUES WITH BRAZING STEP....

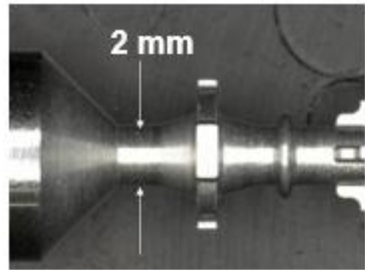


ISSUES WITH BRAZING STEP....



Fabrication of transition section between accelerator modules

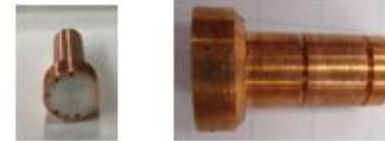
a) Portion of the Aluminum Mandrel



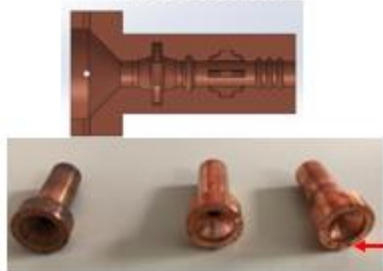
b) Electroformed Mandrel



c) Machining of Electroformed Mandrel



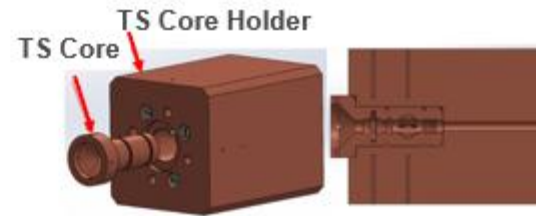
d) Leached Out TS Core



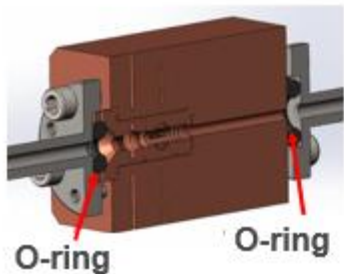
e) Fabrication of TS Holder



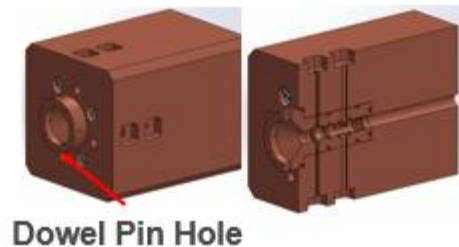
f) Brazing TS Core and TS Core Holder



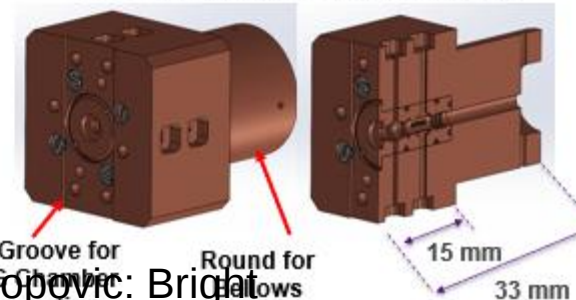
g) Leak Test



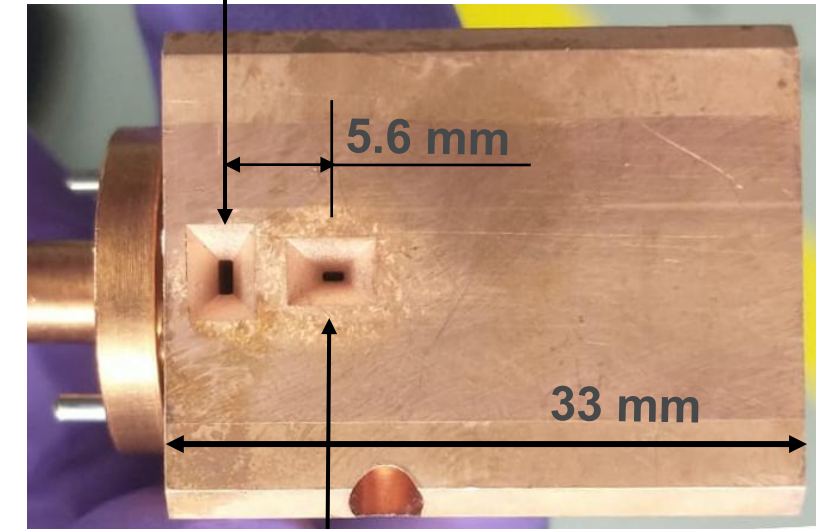
h) EDM of Internal Waveguide



i) Machining of TS Front and Back Faces



TM₀₁ coupler horn antenna, 0.72 mm × 1.78 mm



Integrated offset monitor horn antenna, 1.10 mm × 0.45 mm

MEASUREMENT OF CORRUGATED WAVEGUIDES

- Beam measurement of individual tubes at BNL ATF
- Initial cold testing of assembled 300 mm section?
 - Qualitative measurement
 - Poor performance of the mode convertors
 - Show general transmission
 - Attenuation factor in range of expected
- Beam measurement of assembled 300 mm section at BNL ATF

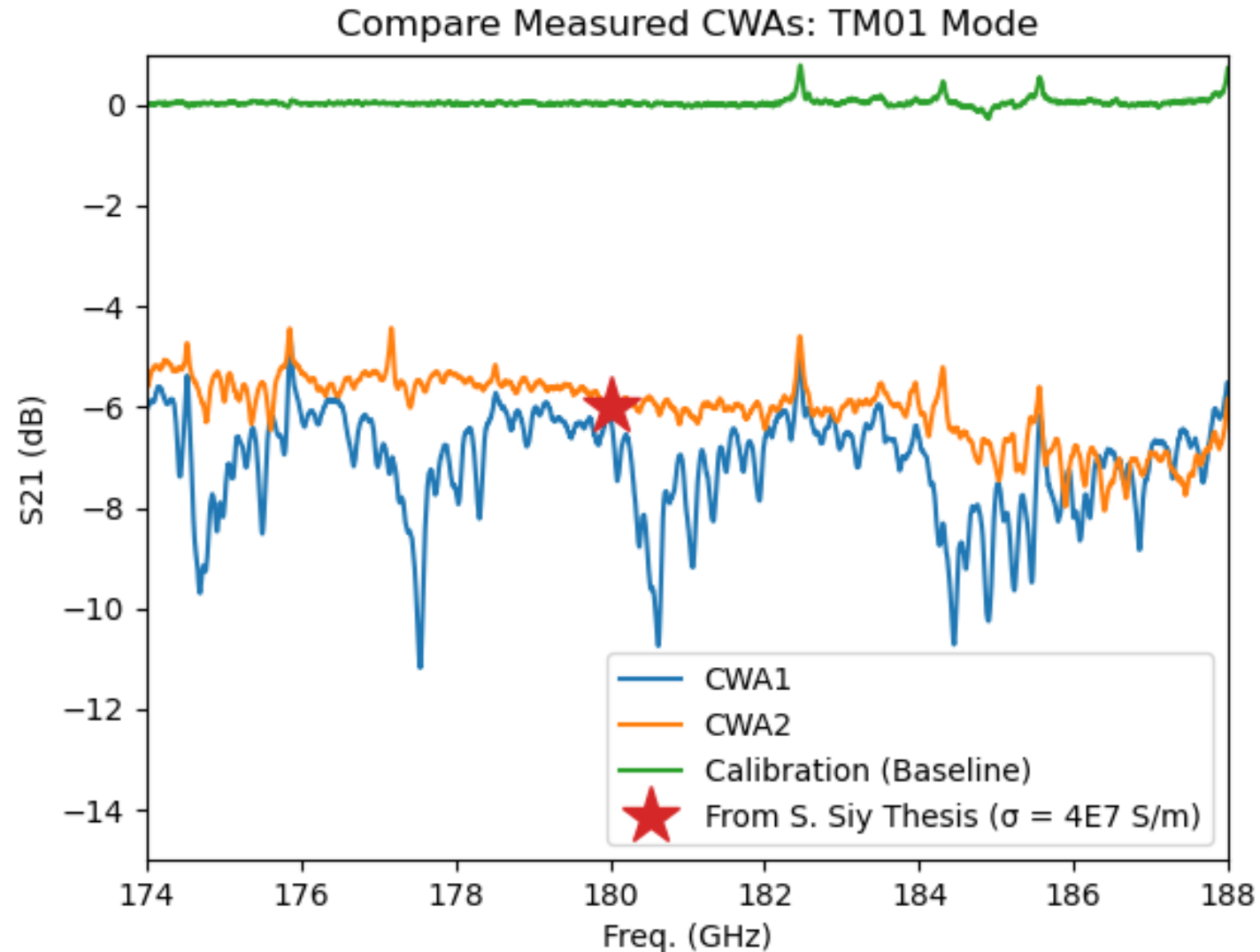
COLD TESTING OF CORRUGATED WAVEGUIDES

Attenuation Factor (From S. Siy Thesis)

	TM ₀₁	HEM ₁₁	Units
f	180	190	GHz
κ	1.18e16	2.19e10/ μm^2	$\text{V C}^{-1} \text{m}^{-1}$
β_g	0.57	0.62	None
α	2.31	1.96	Np m^{-1}

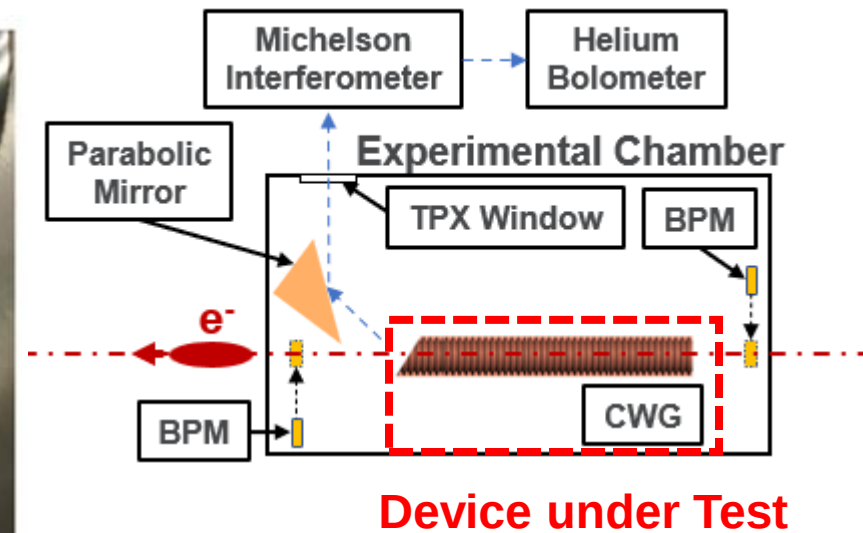
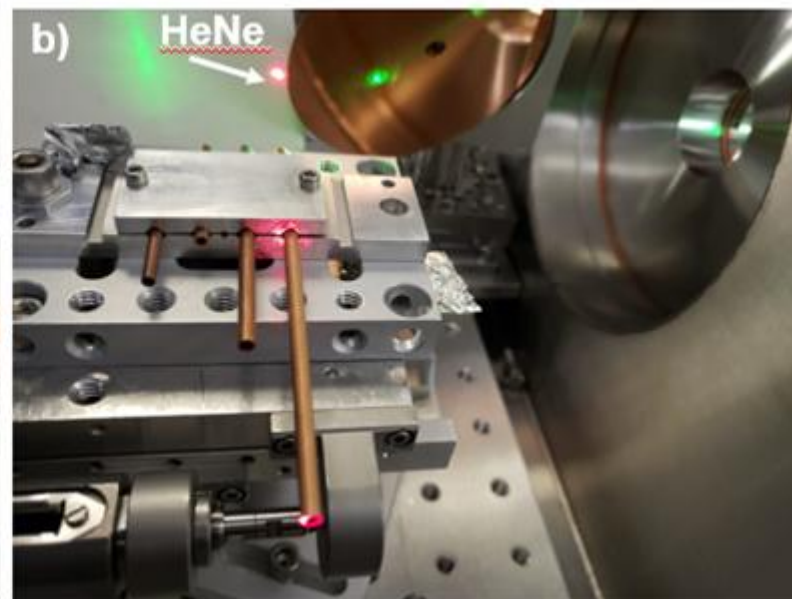
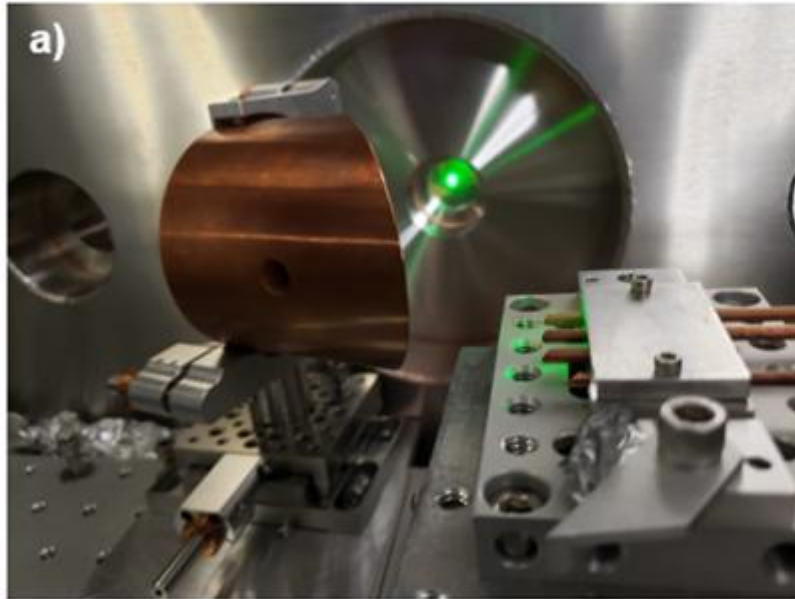
TABLE III. A-STAR synchronous electromagnetic mode characteristics. The loss factor κ for the HEM₁₁ mode scales with the square of the beam offset and the attenuation coefficient α is given for a structure with conductivity of $4 \times 10^7 \text{ S m}^{-1}$.

- For TM01 mode, 300 mm CWA
— 6 dB loss expected



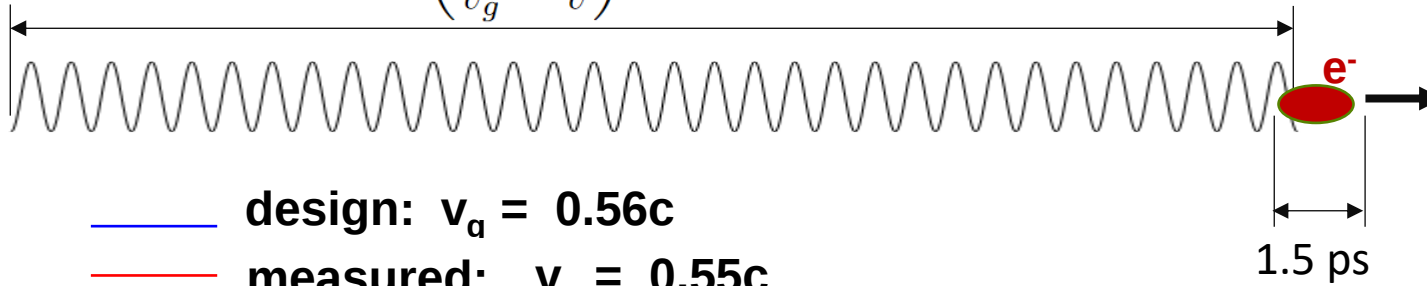
BEAM TESTING AT BNL ATF

Experimental Setup: Chamber with CWG

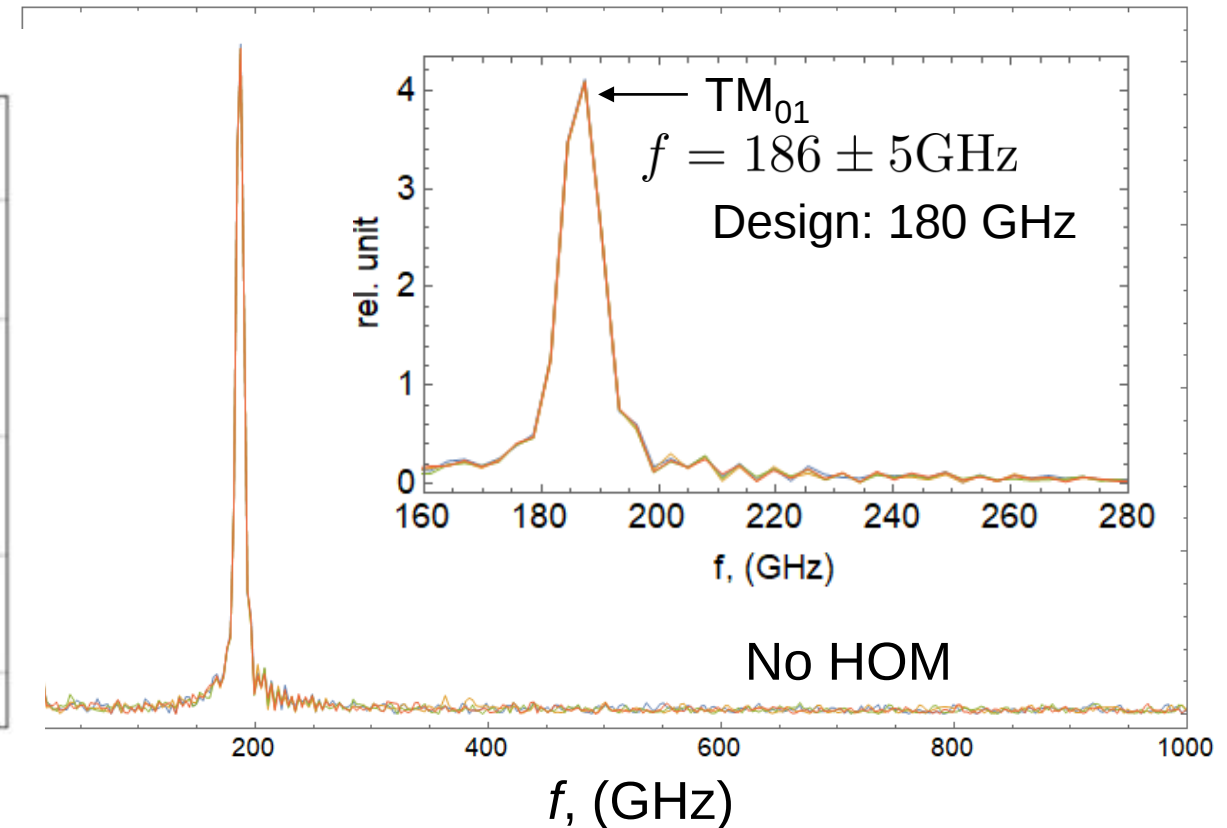
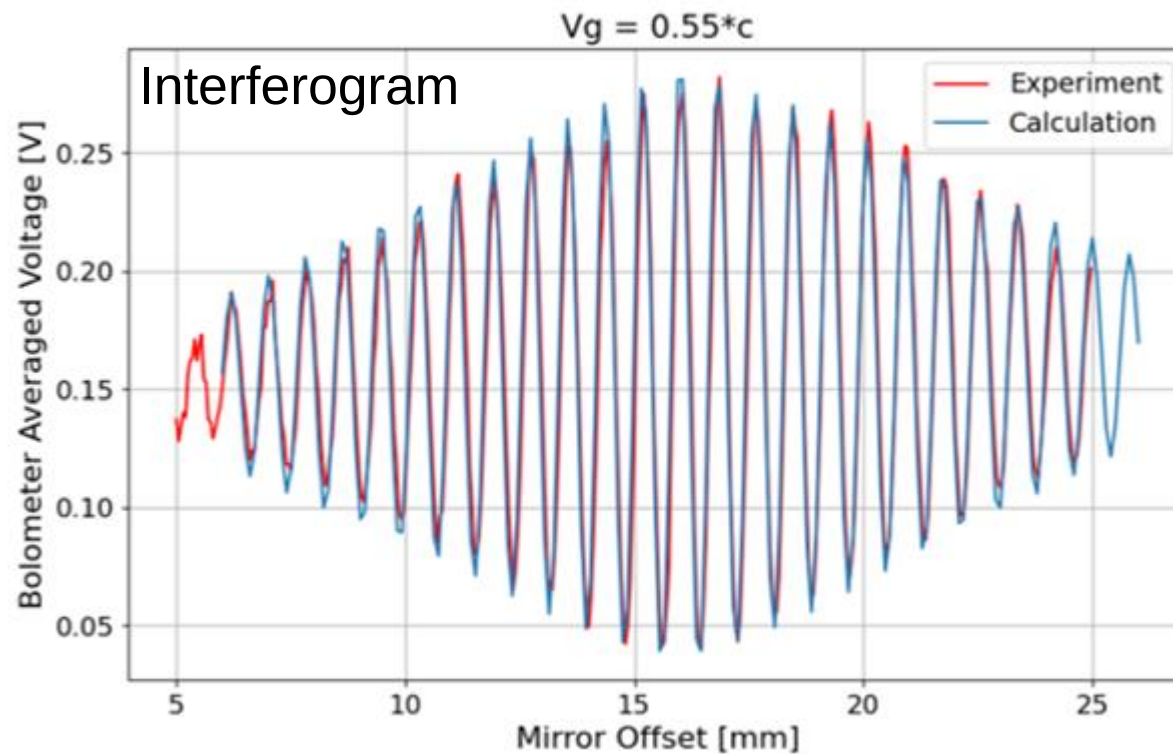


MEASUREMENT OF CWG: FREQUENCY & GROUP VELOCITY

$$\Delta t = L \left(\frac{1}{v_g} - \frac{1}{v} \right) \quad (L=34 \text{ mm})$$

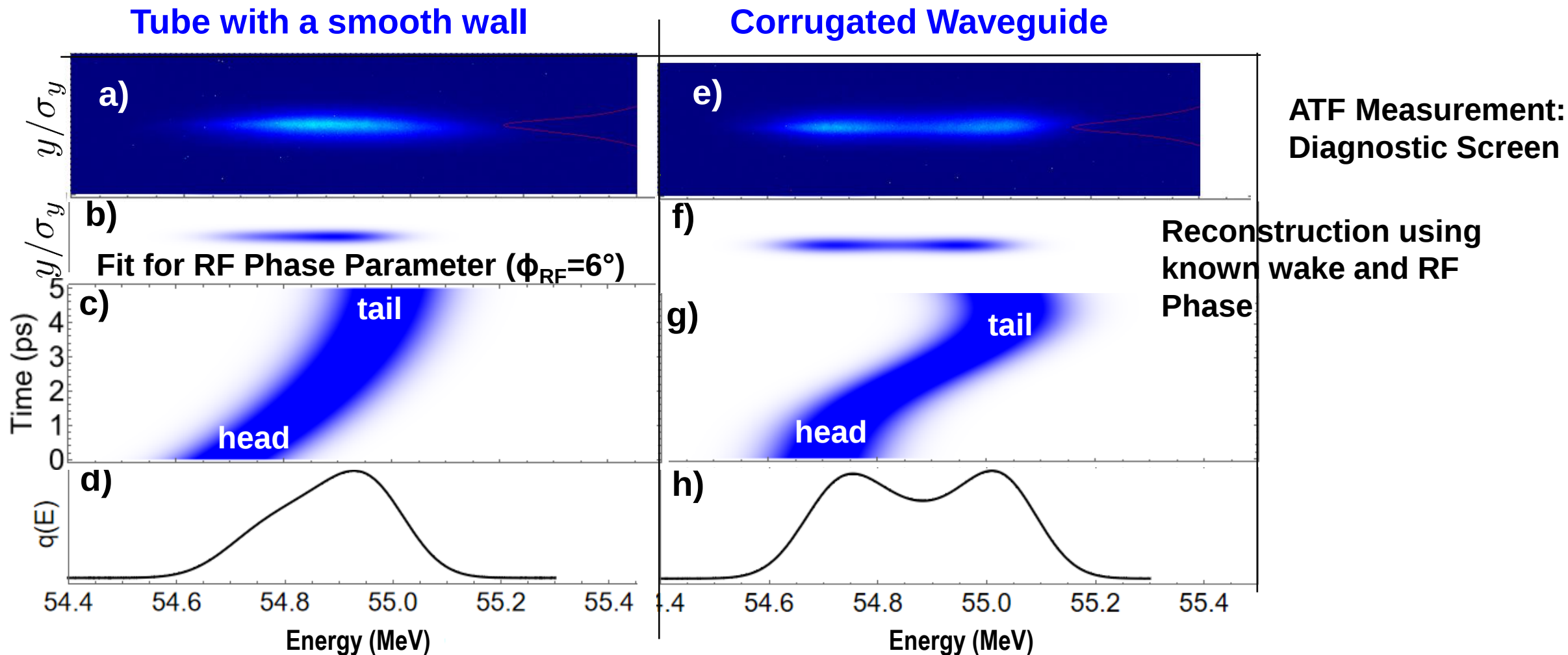


— design: $v_a = 0.56c$
 — measured: $v_g = 0.55c$



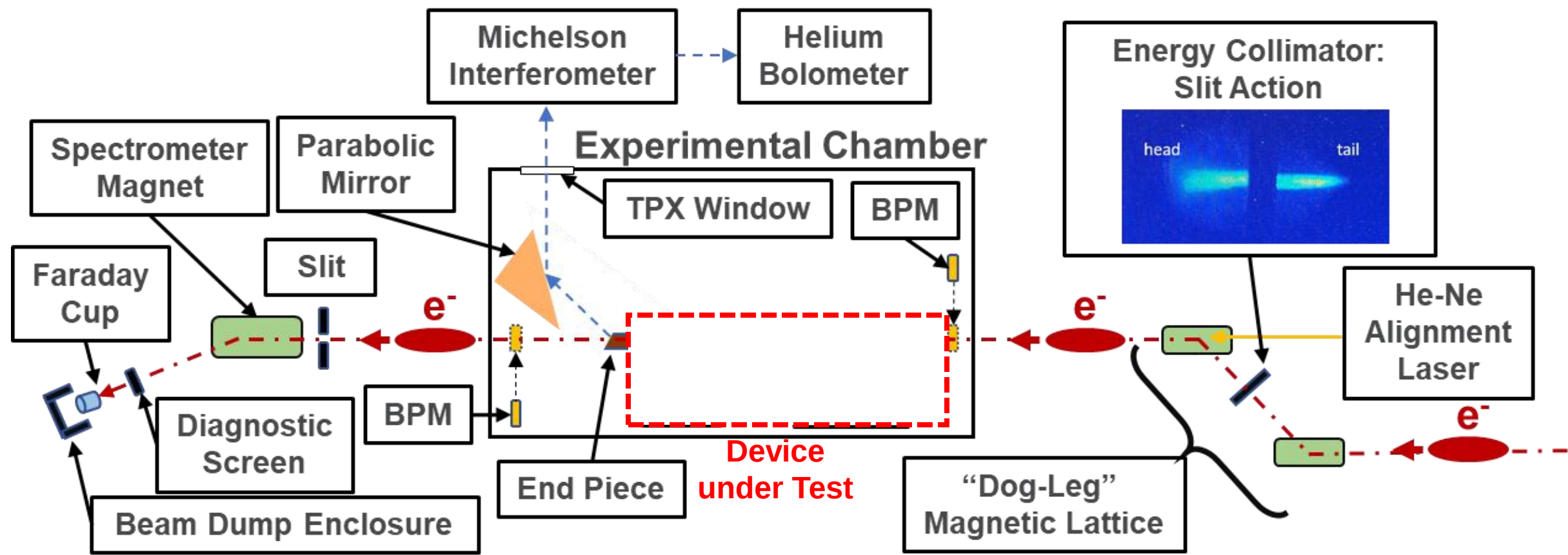
Electron beam self energy modulation by the wakefield

Calculated results for a 5 ps ($\sim \lambda$ TM₀₁ mode), 130 pc bunch with a flattop peak current distribution and 65 keV slice energy spread. Off crest acceleration by 6.0 degree. Tube length=74 mm



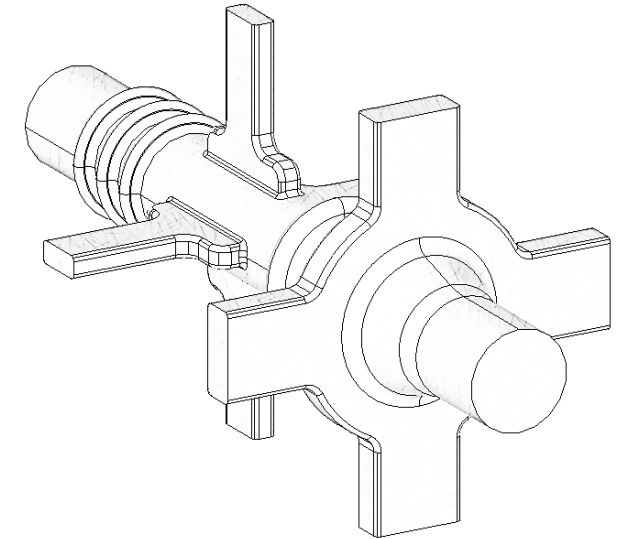
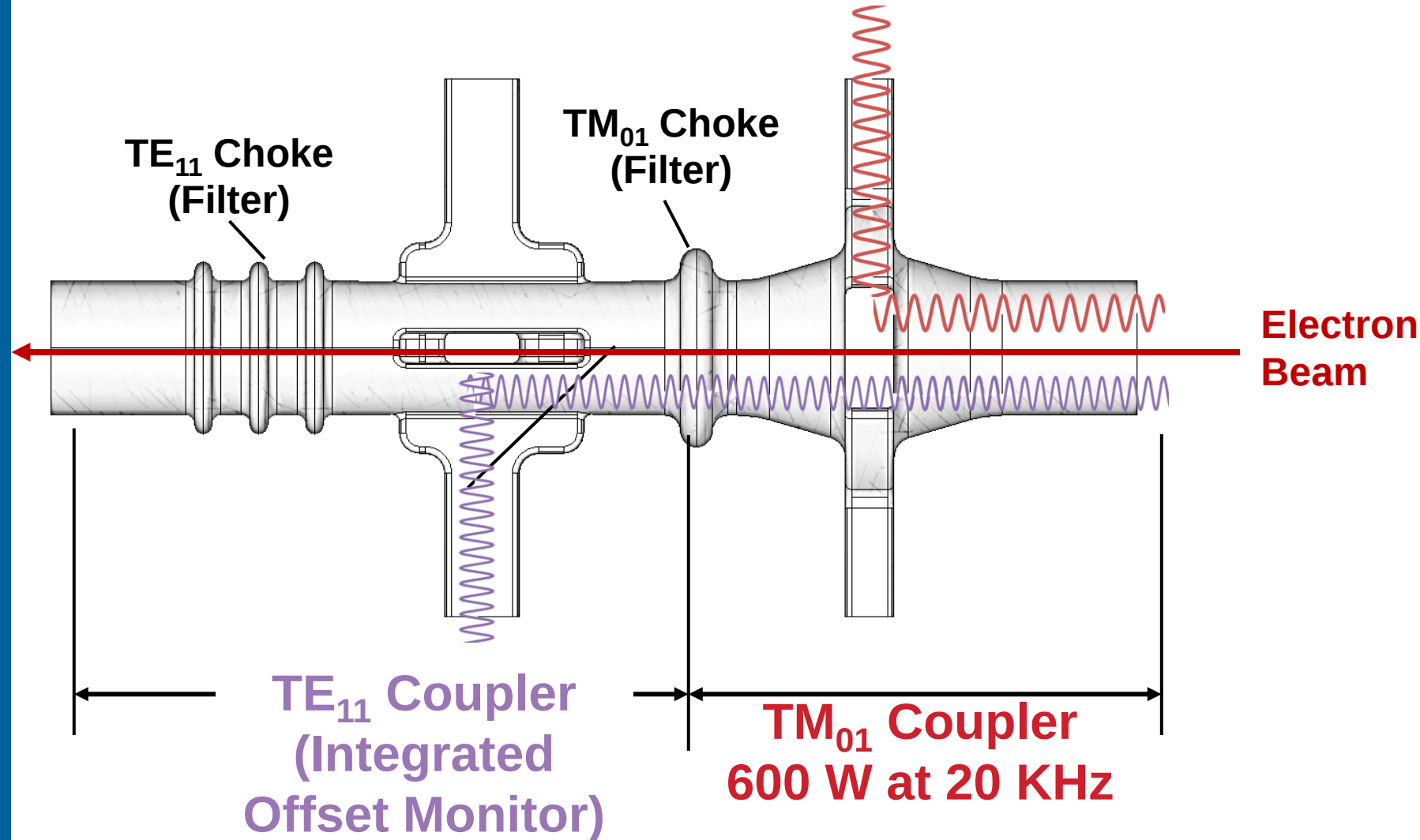
EXPERIMENTAL SETUP AT BNL ATF

Beam Parameters	Value
Beam Energy	55 MeV
Bunch Charge	10-40 pC
Charge Distribution	flat top
Bunch Length, l_b/c	~ 1-2 ps



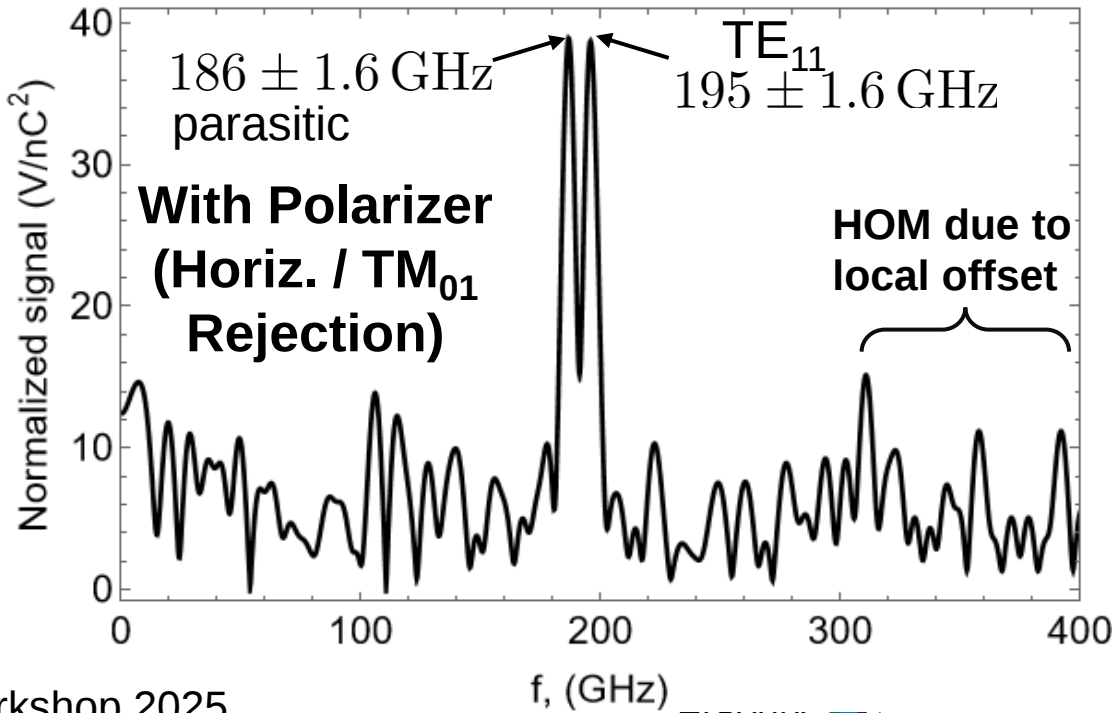
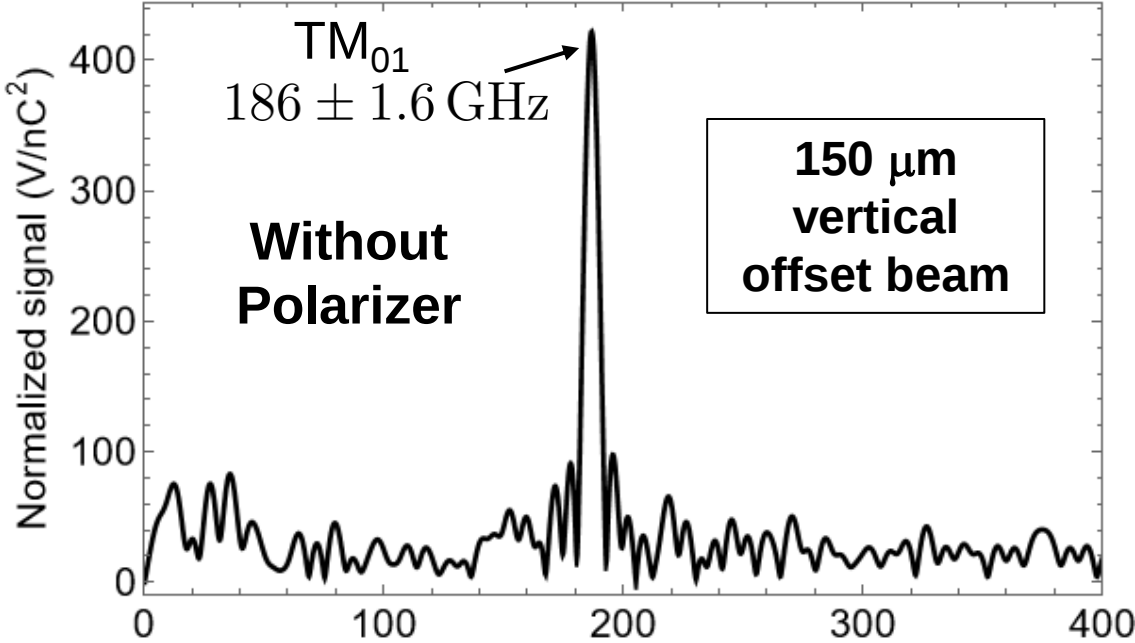
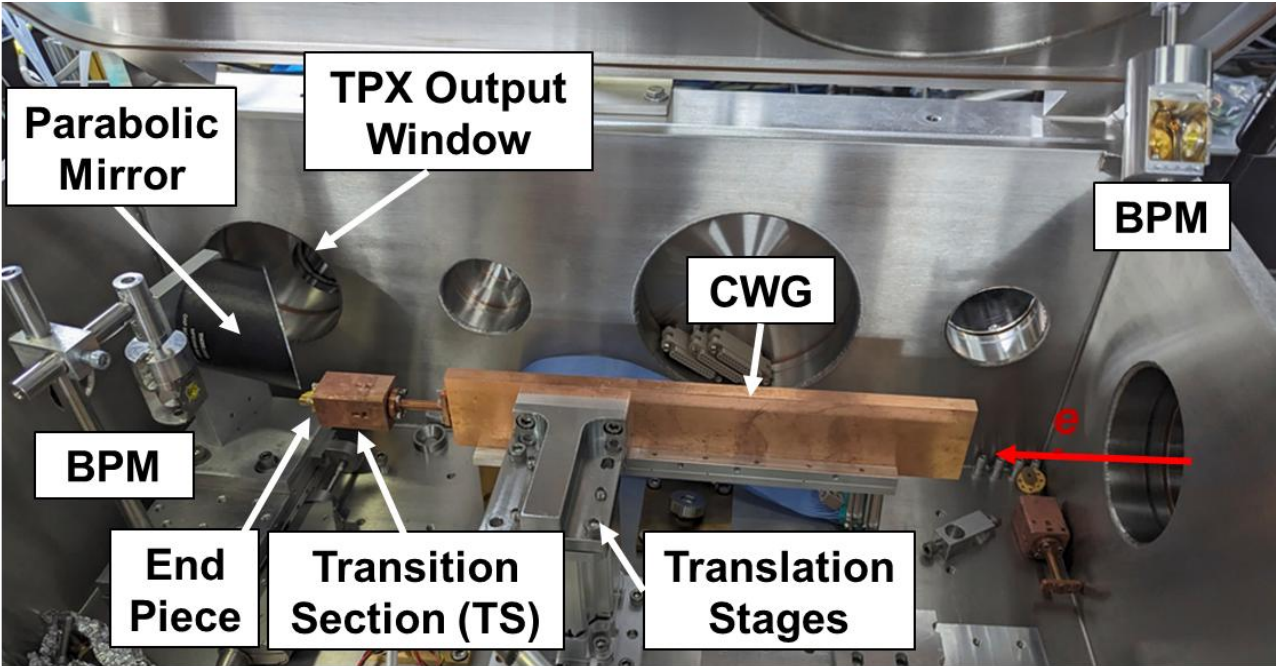
TRANSITION SECTION DESIGN

- Multiple CWG connected via Transition Sections (TS)



TRANSITION SECTION BEAM TESTING AT BNL ATF

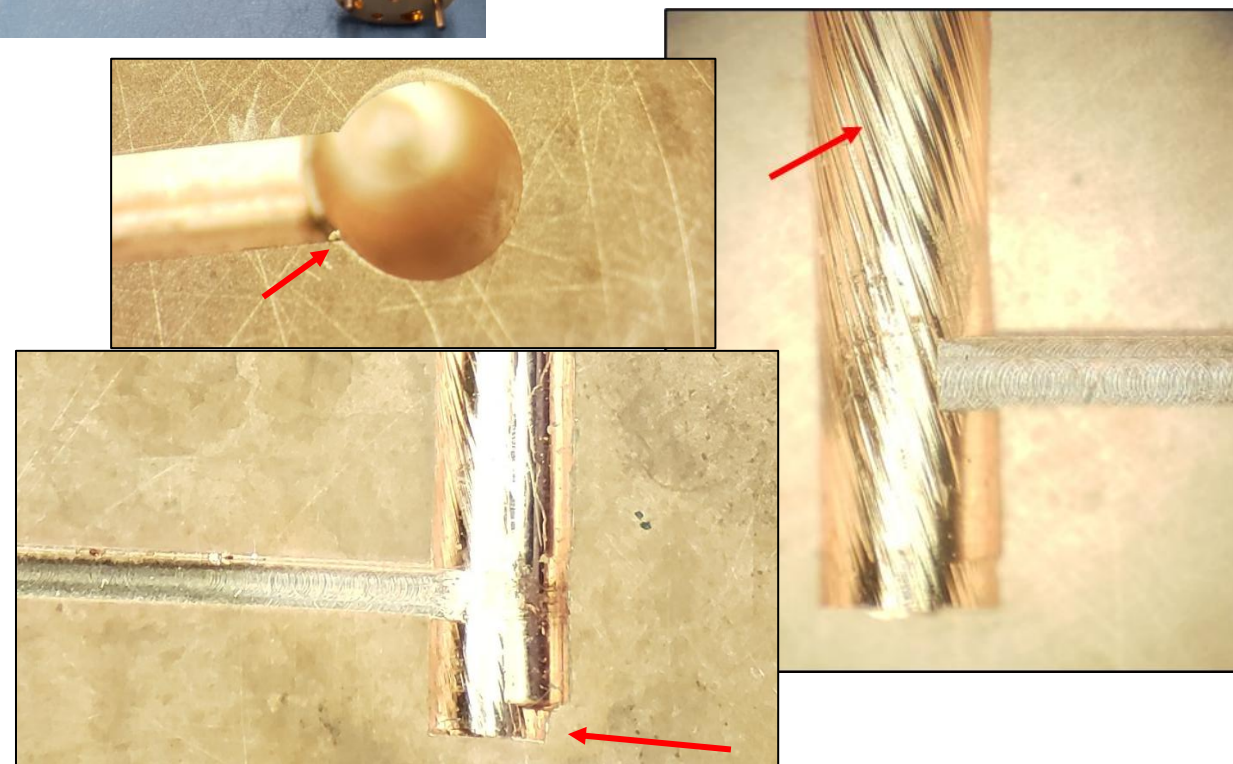
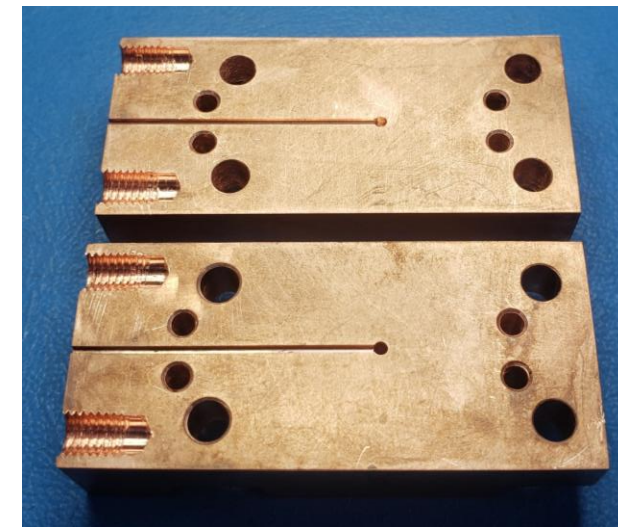
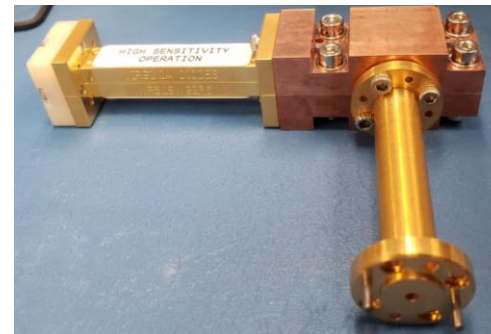
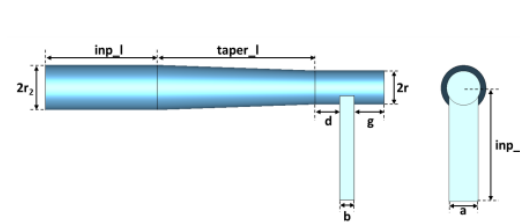
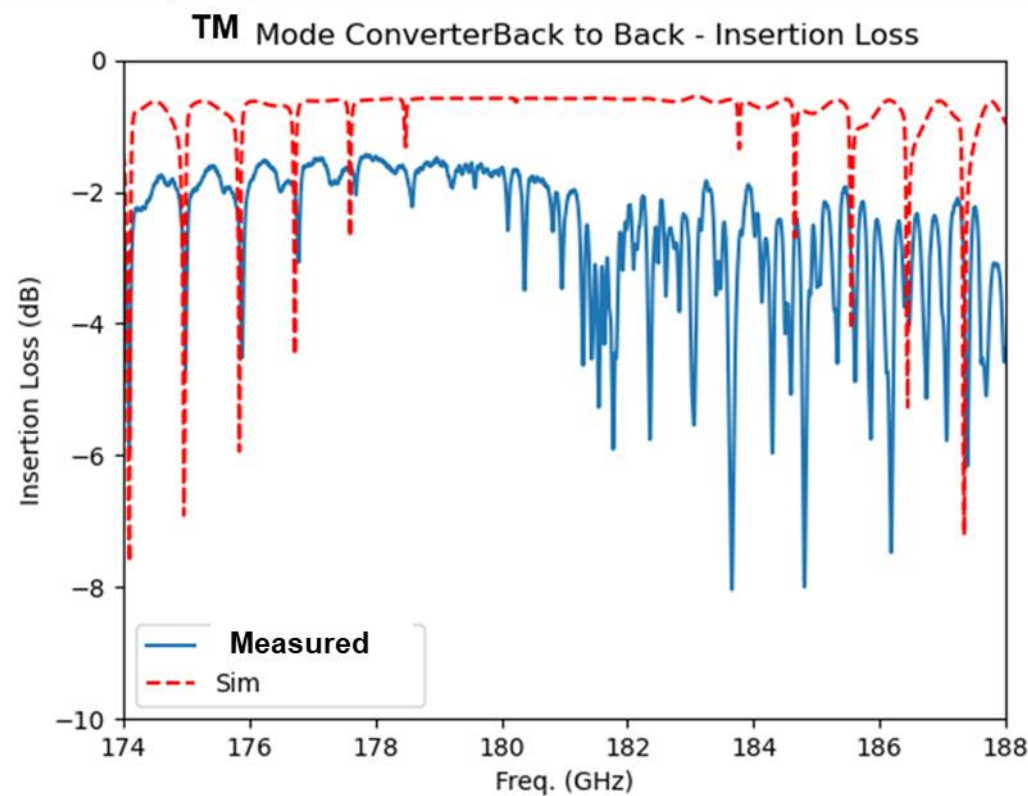
Capture Rate	Mode Coupler	
	TM ₀₁	TE ₁₁
Polarization	Horizontal	Vertical
CWG 1	97.9±0.5%	97.1±1.1%
CWG 2	95.9±1.6%	95.8±3.0%



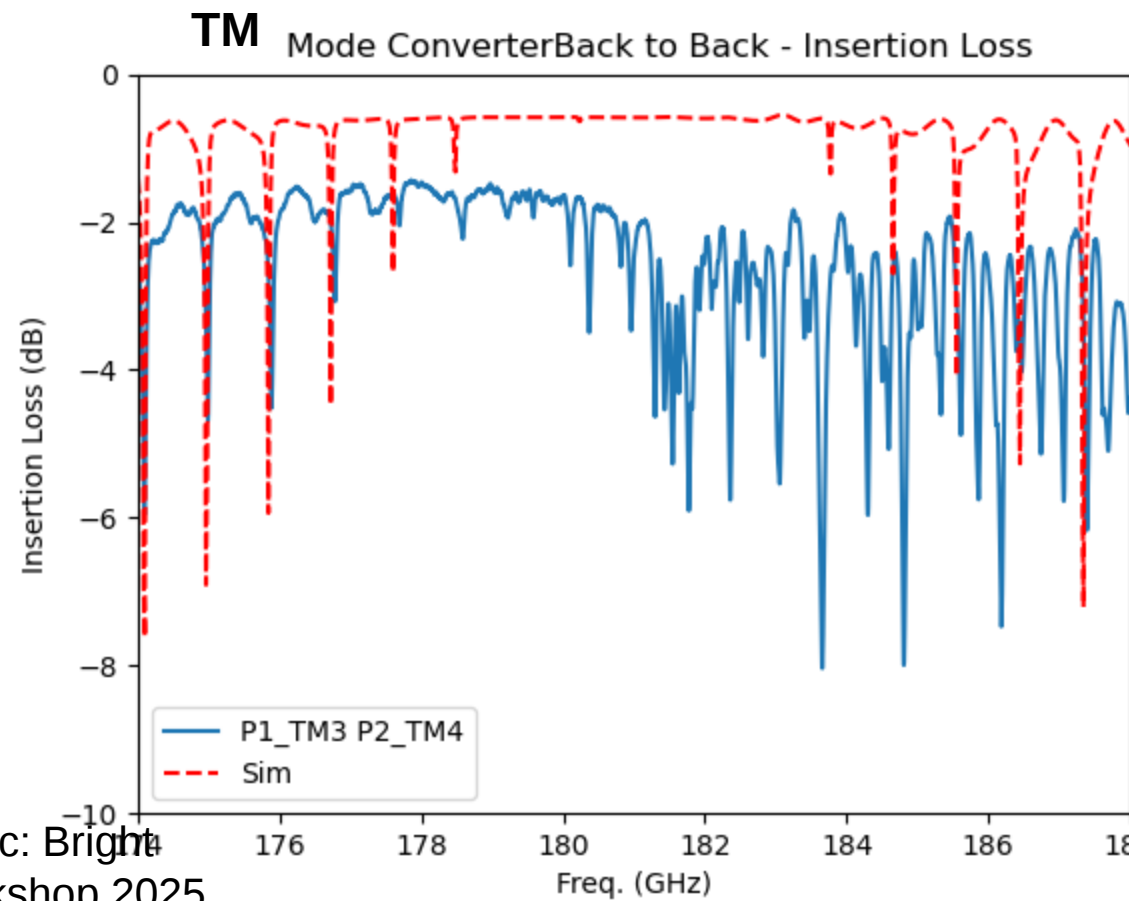
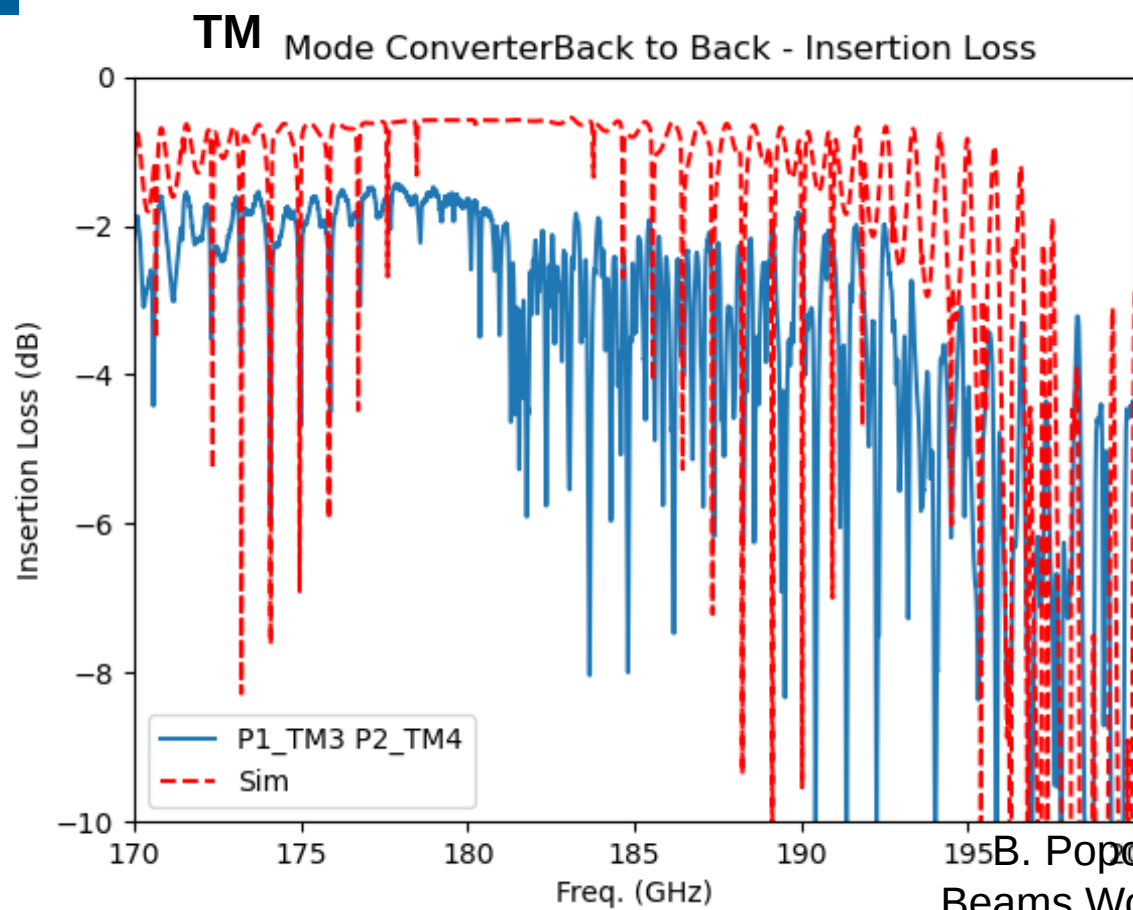
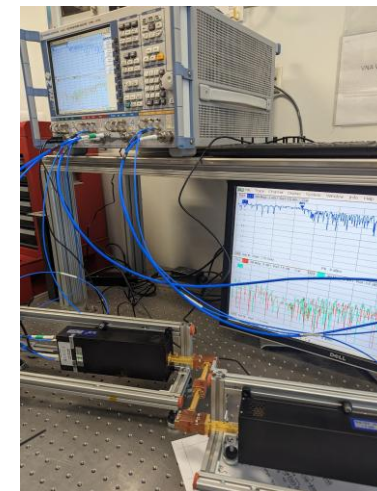
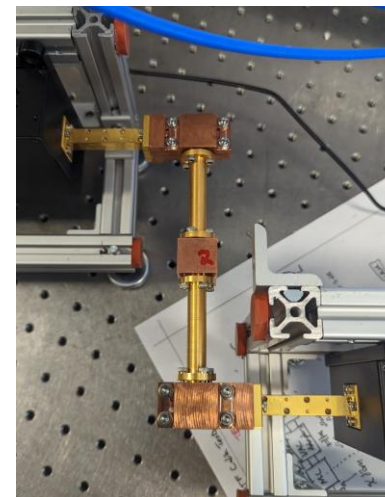
MODE CONVERTORS

WR5 to Circular (TM_{01} & TE_{11})

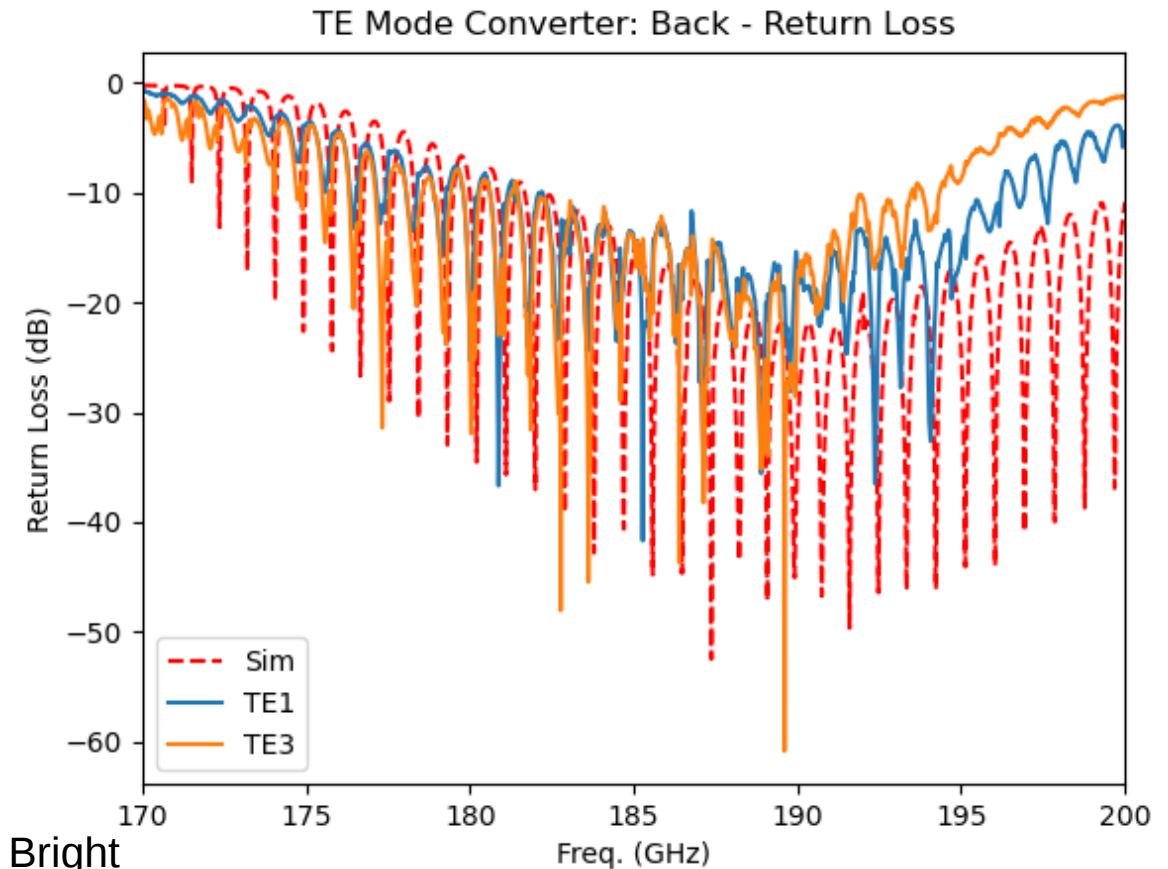
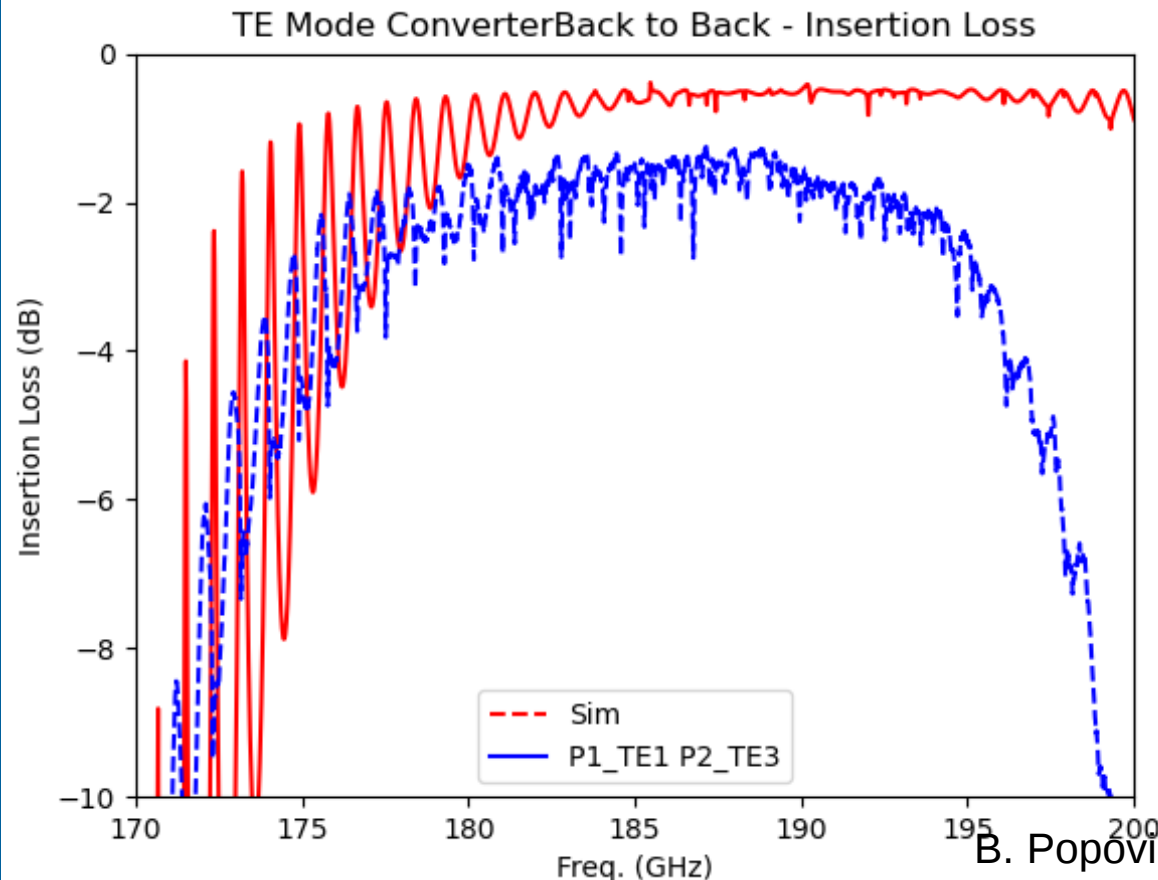
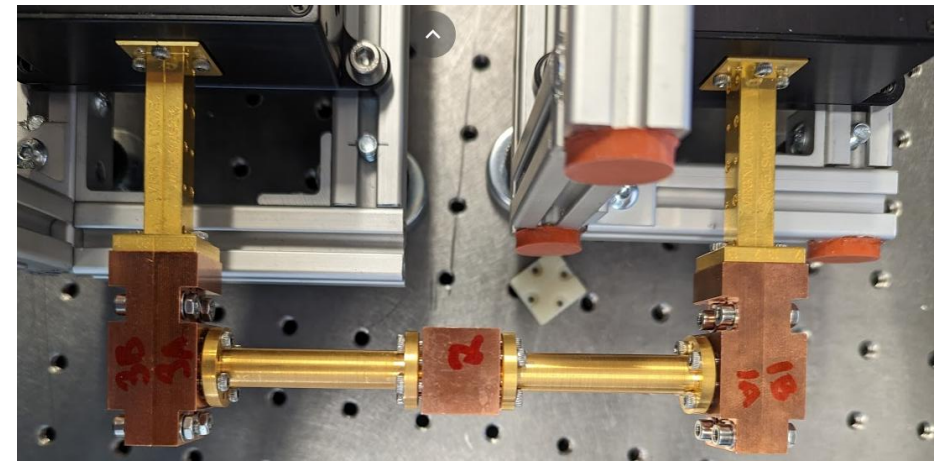
- Traditional Machining



BEST PERFORMING MODE CONVERTORS (TM3 & TM4) : BACK TO BACK



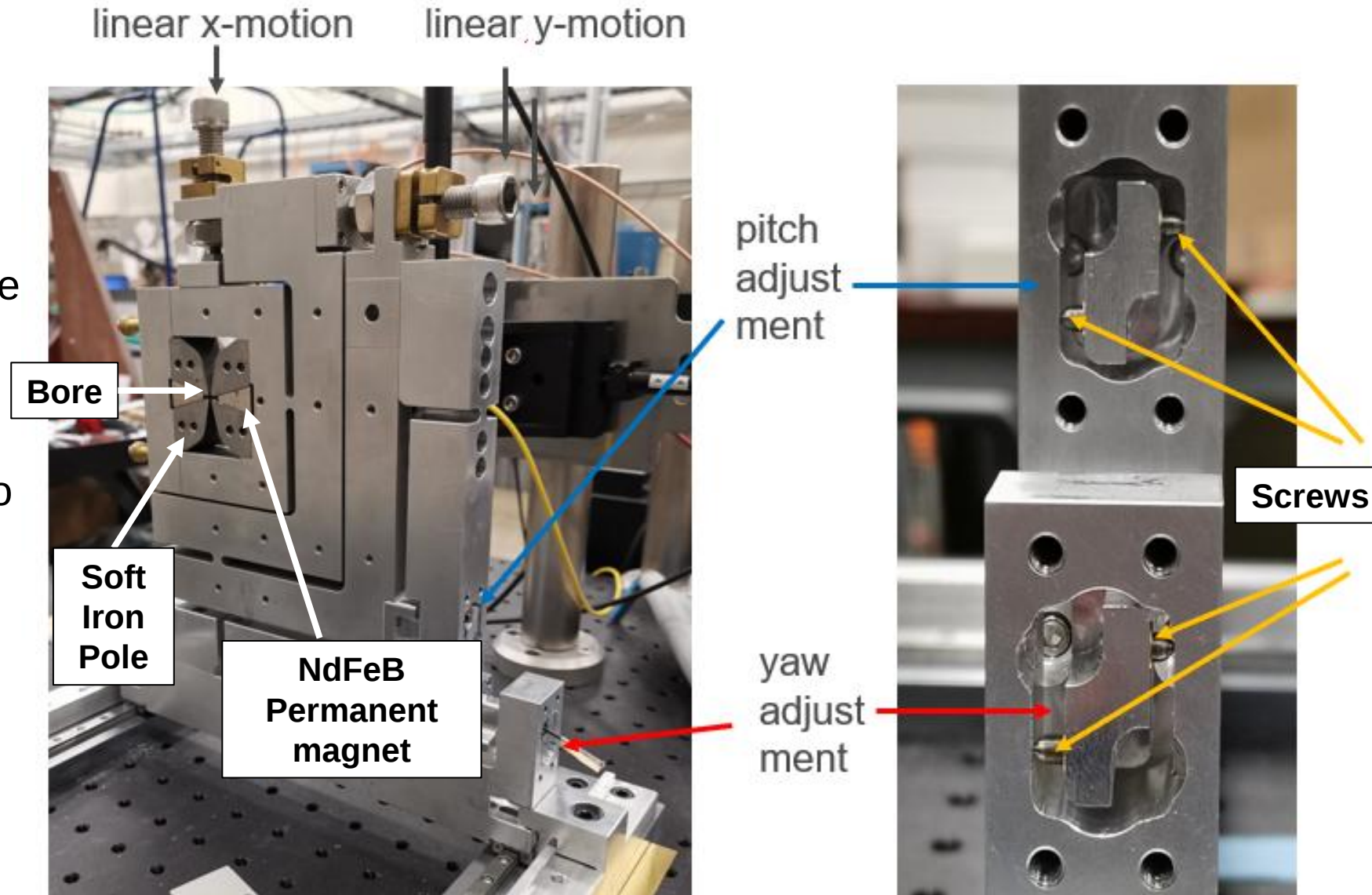
TE11 MODE CONVERTOR: COMPARE TO SIMULATION



DESIGN AND MAGNETIC MEASUREMENTS OF THE QUADRUPOLE WIGGLER

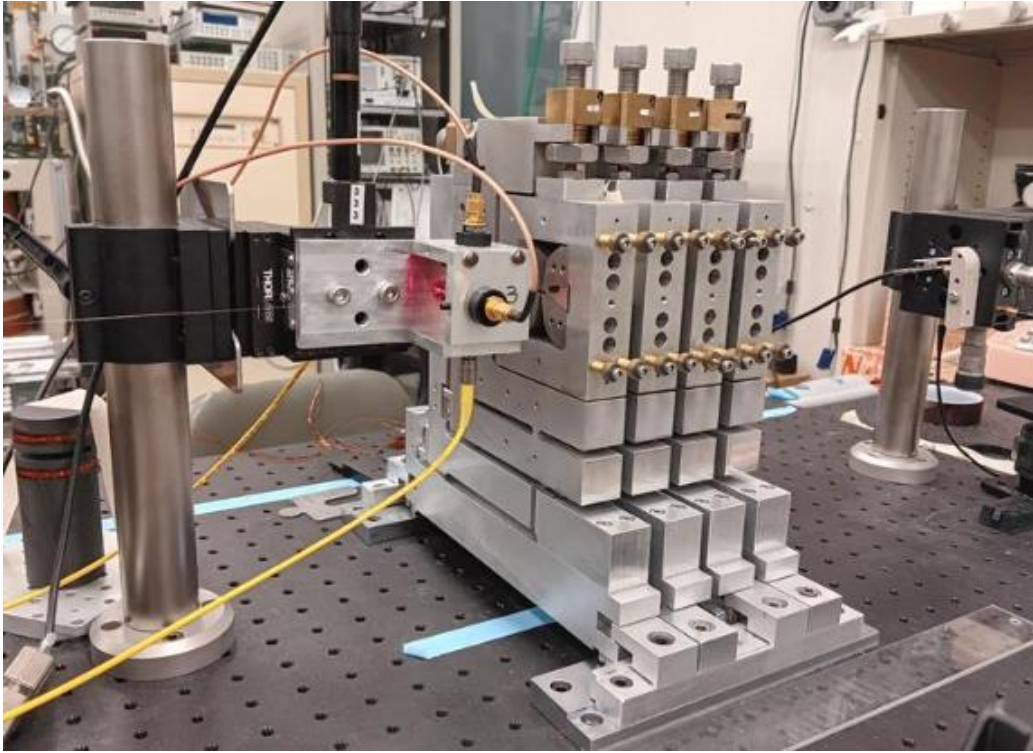
Requirements: (Defined by BBU Suppression)

- Ultimate gradient of the magnetic field
 - Maximum Gradient in the Middle of Quad: 0.95 T
- Smaller than 1 micron misalignment of magnetic centers of all quadrupoles to a common central line
- Smaller than 200 microradians yaw and pitch angle misalignment of individual quadrupoles

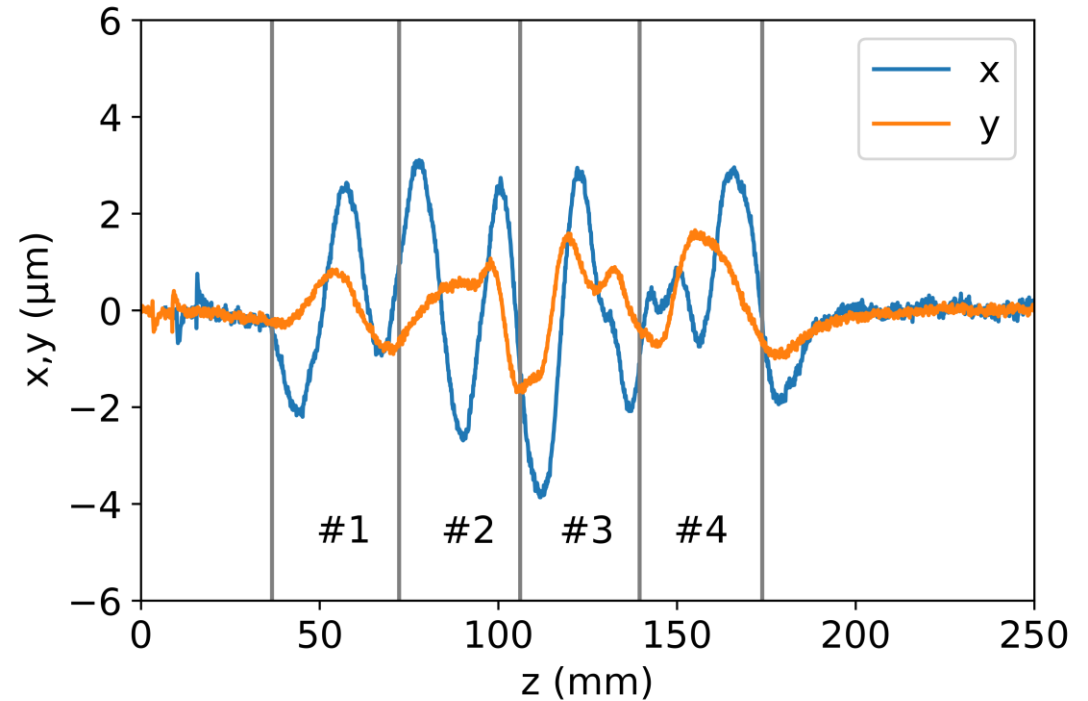


LINAC24: B. Popovic

Measurement of prototype quadrupole wiggler



Temperature dependent drift of the magnetic center was measured as $4.4 \mu\text{m}/^\circ\text{C}$



Alignment of four quadrupoles.

The final quadrupole magnetic axis offset from the wire derived from the first field integral measurement: less than 0.5 microns

The oscillations of the offsets are due to small wavering in the longitudinal profile of the quadrupole poles.